

## Introduction

Kintex™-7 FPGAs are available in -3, -2, -1, and -2L speed grades, with -3 having the highest performance. The -2L devices can operate at either of two  $V_{CCINT}$  voltages, 0.9V and 1.0V and are screened for lower maximum static power. When operated at  $V_{CCINT} = 1.0V$ , the speed specification of a -2L device is the same as the -2 speed grade. When operated at  $V_{CCINT} = 0.9V$ , the -2L performance and static and dynamic power is reduced.

Kintex-7 FPGA DC and AC characteristics are specified in commercial, extended, and industrial temperature ranges. Except the operating temperature range or unless otherwise noted, all the DC and AC electrical parameters are the same for a particular speed grade (that is, the timing

characteristics of a -1 speed grade industrial device are the same as for a -1 speed grade commercial device). However, only selected speed grades and/or devices are available in each temperature range.

All supply voltage and junction temperature specifications are representative of worst-case conditions. The parameters included are common to popular designs and typical applications.

This Kintex-7 FPGA data sheet, part of an overall set of documentation on the 7 series FPGAs, is available on the Xilinx website at [www.xilinx.com/7](http://www.xilinx.com/7).

All specifications are subject to change without notice.

## DC Characteristics

Table 1: Absolute Maximum Ratings (1)

Symbol	Description	Min	Max	Units
<b>FPGA Logic</b>				
$V_{CCINT}$	Internal supply voltage	-0.5	1.1	V
$V_{CCAUX}$	Auxiliary supply voltage	-0.5	2.0	V
$V_{CCBRAM}$	Supply voltage for the block RAM memories	-0.5	1.1	V
$V_{CCO}$	Output drivers supply voltage for 3.3V HR I/O banks	-0.5	3.6	V
	Output drivers supply voltage for 1.8V HP I/O banks	-0.5	2.0	V
$V_{CCAUX\_IO}$	Auxiliary supply voltage	-0.5	2.06	V
$V_{REF}$	Input reference voltage	-0.5	2.0	V
$V_{IN}^{(2)(3)(4)}$	I/O input voltage	-0.5	$V_{CCO} + 0.5$	V
	I/O input voltage for $V_{REF}$ and differential I/O standards.	-0.5	2.625	V
$V_{CCBATT}$	Key memory battery backup supply	-0.5	2.0	V
<b>GTX Transceiver</b>				
$V_{MGTAVCC}$	Analog supply voltage for the GTX transmitter and receiver circuits	-0.5	1.1	V
$V_{MGTAVTT}$	Analog supply voltage for the GTX transmitter and receiver termination circuits	-0.5	1.32	V
$V_{MGTVCCAUX}$	Auxiliary analog Quad PLL (QPLL) voltage supply for the GTX transceivers	-0.5	1.935	V
$V_{MGTREFCLK}$	GTX transceiver reference clock absolute input voltage	-0.5	1.32	V
$V_{MGTAVTTRCAL}$	Analog supply voltage for the resistor calibration circuit of the GTX transceiver column	-0.5	1.32	V
$V_{IN}$	Receiver (RXP/RXN) and Transmitter (TXP/TXN) absolute input voltage	-0.5	1.26	V

**Table 1: Absolute Maximum Ratings (1) (Cont'd)**

Symbol	Description	Min	Max	Units
I <sub>DCIN</sub>	DC input current for receiver input pins DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	14	mA
I <sub>DCOUT</sub>	DC output current for transmitter pins DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	14	mA
<b>XADC</b>				
V <sub>CCADC</sub>	XADC supply relative to GNDADC	–0.5	2.0	V
V <sub>REFP</sub>	XADC reference input relative to GNDADC	–0.5	2.0	V
<b>Temperature</b>				
T <sub>STG</sub>	Storage temperature (ambient)	–65	150	°C
T <sub>SOL</sub>	Maximum soldering temperature for Pb/Sn component bodies (6)	–	+220	°C
	Maximum soldering temperature for Pb-free component bodies (6)	–	+260	°C
T <sub>j</sub>	Maximum junction temperature(6)	–	+125	°C

**Notes:**

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.
- The lower absolute voltage specification always applies.
- For I/O operation, refer to [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).
- The maximum limit applied to DC and AC signals.
- For maximum undershoot and overshoot AC specifications, see [Table 4](#) and [Table 5](#).
- For soldering guidelines and thermal considerations, see [UG475: 7 Series FPGA Packaging and Pinout Specification](#).

**Table 2: Recommended Operating Conditions (1)**

Symbol	Description	Min	Typ	Max	Units
<b>FPGA Logic</b>					
V <sub>CCINT</sub> (2)	Internal supply voltage	0.97	1.00	1.03	V
	For -2L (0.9V) devices: internal supply voltage	0.87	0.90	0.93	V
V <sub>CCBRAM</sub> (2)	Block RAM supply voltage	0.97	1.00	1.03	V
	For -2L (0.9V) devices: block RAM supply voltage	0.87	0.90	1.03	V
V <sub>CCAUX</sub>	Auxiliary supply voltage	1.71	1.80	1.89	V
V <sub>CCO</sub> (3)(4)	Supply voltage for 3.3V HR I/O banks	1.14	–	3.465	V
	Supply voltage for 1.8V HP I/O banks	1.14	–	1.89	V
V <sub>CCAUX_IO</sub>	Auxiliary supply voltage when set to 1.8V	1.71	1.80	1.89	V
	Auxiliary supply voltage when set to 2.0V	1.94	2.00	2.06	V
V <sub>IN</sub> (5)	I/O input voltage	–0.20	–	V <sub>CCO</sub> + 0.2	V
	I/O input voltage for V <sub>REF</sub> and differential I/O standards	–0.20	–	2.625	V
I <sub>IN</sub> (6)	Maximum current through any pin in a powered or unpowered bank when forward biasing the clamp diode.	–	–	10	mA
V <sub>CCBATT</sub> (7)	Battery voltage	1.0	–	1.89	V
<b>GTX Transceiver</b>					
V <sub>MGTAVCC</sub> (8)	Analog supply voltage for the GTX transceiver QPLL frequency range ≤ 10.3125 GHz(9)(10)	0.97	1.0	1.08	V
	Analog supply voltage for the GTX transceiver QPLL frequency range > 10.3125 GHz	1.02	1.05	1.08	V
V <sub>MGTAVTT</sub> (8)	Analog supply voltage for the GTX transmitter and receiver termination circuits	1.17	1.2	1.23	V
V <sub>MGTVCCAUX</sub> (8)	Auxiliary analog QPLL voltage supply for the transceivers	1.75	1.80	1.85	V

**Table 2: Recommended Operating Conditions (1) (Cont'd)**

Symbol	Description	Min	Typ	Max	Units
$V_{MGTAVTTRCAL}$ (8)	Analog supply voltage for the resistor calibration circuit of the GTX transceiver column	1.17	1.2	1.23	V
<b>XADC</b>					
$V_{CCADC}$	XADC supply relative to GNDADC	1.71	1.80	1.89	V
$V_{REFP}$	Externally supplied reference voltage	1.20	1.25	1.30	V
<b>Temperature</b>					
$T_j$	Junction temperature operating range for commercial (C) temperature devices	0	–	85	°C
	Junction temperature operating range for extended (E) temperature devices	0	–	100	°C
	Junction temperature operating range for industrial (I) temperature devices	–40	–	100	°C

**Notes:**

- All voltages are relative to ground.
- $V_{CCINT}$  and  $V_{CCBRAM}$  should be connected to the same supply.
- Configuration data is retained even if  $V_{CCO}$  drops to 0V.
- Includes  $V_{CCO}$  of 1.2V, 1.5V, 1.8V, 2.5V, and 3.3V.
- The lower absolute voltage specification always applies.
- A total of 200 mA per bank should not be exceeded.
- $V_{CCBATT}$  is required only when using bitstream encryption. If battery is not used, connect  $V_{CCBATT}$  to either ground or  $V_{CCAUX}$ .
- Each voltage listed requires the filter circuit described in [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#).
- For data rates  $\leq 10.3125$  Gb/s,  $V_{MGTAVCC}$  should be  $1.0V \pm 3\%$  for lower power consumption.
- For lower power consumption,  $V_{MGTAVCC}$  should be  $1.0V \pm 3\%$  over the entire CPLL frequency range.

**Table 3: DC Characteristics Over Recommended Operating Conditions**

Symbol	Description	Min	Typ(1)	Max	Units
$V_{DRINT}$	Data retention $V_{CCINT}$ voltage (below which configuration data might be lost)	0.75	–	–	V
$V_{DRI}$	Data retention $V_{CCAUX}$ voltage (below which configuration data might be lost)	1.5	–	–	V
$I_{REF}$	$V_{REF}$ leakage current per pin	–	–	15	$\mu A$
$I_L$	Input or output leakage current per pin (sample-tested)	–	–	15	$\mu A$
$C_{IN}$ (2)	Die input capacitance at the pad	–	–	8	pF
$I_{RPU}$	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 3.3V$	90	–	330	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 2.5V$	68	–	250	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 1.8V$	34	–	220	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 1.5V$	23	–	150	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 1.2V$	12	–	120	$\mu A$
$I_{RPD}$	Pad pull-down (when selected) @ $V_{IN} = 3.3V$	68	–	330	$\mu A$
	Pad pull-down (when selected) @ $V_{IN} = 1.8V$	45	–	180	$\mu A$
$I_{CCADC}$	Analog supply current, analog circuits in powered up state	–	–	25	mA
$I_{BATT}$ (3)	Battery supply current	–	–	150	nA

**Table 3: DC Characteristics Over Recommended Operating Conditions (Cont'd)**

Symbol	Description	Min	Typ <sup>(1)</sup>	Max	Units
$R_{IN\_TERM}^{(4)}$	Thevenin equivalent resistance of programmable input termination to $V_{CCO}/2$ (UNTUNED_SPLIT_40) for commercial (C), industrial (I), and extended (E) temperature devices	28	40	55	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}/2$ (UNTUNED_SPLIT_50) for commercial (C), industrial (I), and extended (E) temperature devices	35	50	65	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}/2$ (UNTUNED_SPLIT_60) for commercial (C), industrial (I), and extended (E) temperature devices	44	60	83	$\Omega$
n	Temperature diode ideality factor	–	1.010	–	–
r	Temperature diode series resistance	–	2	–	$\Omega$

**Notes:**

1. Typical values are specified at nominal voltage, 25°C.
2. This measurement represents the die capacitance at the pad, not including the package.
3. Maximum value specified for worst case process at 25°C.
4. Termination resistance to a  $V_{CCO}/2$  level.

**Table 4: Maximum Allowed AC Voltage Overshoot and Undershoot for 3.3V HR I/O Banks<sup>(1)</sup>**

AC Voltage Overshoot	% of UI @–40°C to 100°C	AC Voltage Undershoot	% of UI @–40°C to 100°C
$V_{CCO} + 0.40$	100	–0.40	100
$V_{CCO} + 0.45$	100	–0.45	61.7
$V_{CCO} + 0.50$	100	–0.50	25.8
$V_{CCO} + 0.55$	100	–0.55	11.0
$V_{CCO} + 0.60$	46.6	–0.60	4.77
$V_{CCO} + 0.65$	21.2	–0.65	2.10
$V_{CCO} + 0.70$	9.75	–0.70	0.94
$V_{CCO} + 0.75$	4.55	–0.75	0.43
$V_{CCO} + 0.80$	2.15	–0.80	0.20
$V_{CCO} + 0.85$	1.02	–0.85	0.09
$V_{CCO} + 0.90$	0.49	–0.90	0.04
$V_{CCO} + 0.95$	0.24	–0.95	0.02

**Notes:**

1. A total of 200 mA per bank should not be exceeded.

**Table 5: Maximum Allowed AC Voltage Overshoot and Undershoot for 1.8V HP I/O Banks<sup>(1)(2)</sup>**

AC Voltage Overshoot	% of UI @–40°C to 100°C	AC Voltage Undershoot	% of UI @–40°C to 100°C
$V_{CCO} + 0.40$	100	–0.40	100
$V_{CCO} + 0.45$	100	–0.45	100
$V_{CCO} + 0.50$	100	–0.50	100
$V_{CCO} + 0.55$	100	–0.55	100
$V_{CCO} + 0.60$	50.0	–0.60	50.0
$V_{CCO} + 0.65$	50.0	–0.65	50.0
$V_{CCO} + 0.70$	47.0	–0.70	50.0
$V_{CCO} + 0.75$	21.2	–0.75	50.0

Table 5: Maximum Allowed AC Voltage Overshoot and Undershoot for 1.8V HP I/O Banks<sup>(1)(2)</sup> (Cont'd)

AC Voltage Overshoot	% of UI @-40°C to 100°C	AC Voltage Undershoot	% of UI @-40°C to 100°C
V <sub>CCO</sub> + 0.80	9.71	-0.80	50.0
V <sub>CCO</sub> + 0.85	4.51	-0.85	28.4
V <sub>CCO</sub> + 0.90	2.12	-0.90	12.7
V <sub>CCO</sub> + 0.95	1.01	-0.95	5.79

**Notes:**

1. A total of 200 mA per bank should not be exceeded.
2. For UI smaller than 20 μs.

Table 6: Typical Quiescent Supply Current

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
I <sub>CCINTQ</sub>	Quiescent V <sub>CCINT</sub> supply current	XC7K70T	241	241	241	187	mA
		XC7K160T	474	474	474	368	mA
		XC7K325T	810	810	810	629	mA
		XC7K355T	993	993	993	771	mA
		XC7K410T	1080	1080	1080	838	mA
		XC7K420T	1313	1313	1313	1019	mA
		XC7K480T	1313	1313	1313	1019	mA
I <sub>CCOQ</sub>	Quiescent V <sub>CCO</sub> supply current	XC7K70T	1	1	1	1	mA
		XC7K160T	1	1	1	1	mA
		XC7K325T	1	1	1	1	mA
		XC7K355T	1	1	1	1	mA
		XC7K410T	1	1	1	1	mA
		XC7K420T	1	1	1	1	mA
		XC7K480T	1	1	1	1	mA
I <sub>CCAUXQ</sub>	Quiescent V <sub>CCAUX</sub> supply current	XC7K70T	21	21	21	21	mA
		XC7K160T	40	40	40	40	mA
		XC7K325T	68	68	68	68	mA
		XC7K355T	75	75	75	75	mA
		XC7K410T	85	85	85	85	mA
		XC7K420T	99	99	99	99	mA
		XC7K480T	99	99	99	99	mA
I <sub>CCAUX_IOQ</sub>	Quiescent V <sub>CCAUX_IO</sub> supply current	XC7K70T	N/A	N/A	N/A	N/A	mA
		XC7K160T	2	2	2	2	mA
		XC7K325T	2	2	2	2	mA
		XC7K355T	N/A	N/A	N/A	N/A	mA
		XC7K410T	2	2	2	2	mA
		XC7K420T	N/A	N/A	N/A	N/A	mA
		XC7K480T	N/A	N/A	N/A	N/A	mA

Table 6: Typical Quiescent Supply Current (Cont'd)

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
I <sub>CCBRAMQ</sub>	Quiescent V <sub>CCBRAM</sub> supply current	XC7K70T	6	6	6	6	mA
		XC7K160T	14	14	14	14	mA
		XC7K325T	19	19	19	19	mA
		XC7K355T	31	31	31	31	mA
		XC7K410T	34	34	34	34	mA
		XC7K420T	41	41	41	41	mA
		XC7K480T	41	41	41	41	mA

**Notes:**

1. Typical values are specified at nominal voltage, 85°C junction temperatures (T<sub>j</sub>) with single-ended SelectIO resources.
2. Typical values are for blank configured devices with no output current loads, no active input pull-up resistors, all I/O pins are 3-state and floating.
3. Use the XPower™ Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate static power consumption for conditions other than those specified.

### Power-On/Off Power Supply Sequencing

The recommended power-on sequence is V<sub>CCINT</sub>, V<sub>CCBRAM</sub>, V<sub>CCAUX</sub>, V<sub>CCAUX\_IO</sub>, and V<sub>CCO</sub> to achieve minimum current draw and ensure that the I/Os are 3-stated at power-on. The recommended power-off sequence is the reverse of the power-on sequence. If V<sub>CCINT</sub> and V<sub>CCBRAM</sub> have the same recommended voltage levels then both can be powered by the same supply and ramped simultaneously. If V<sub>CCAUX</sub>, V<sub>CCAUX\_IO</sub>, and V<sub>CCO</sub> have the same recommended voltage levels then they can be powered by the same supply and ramped simultaneously.

For V<sub>CCO</sub> voltages of 3.3V in HR I/O banks and configuration bank 0:

- The voltage difference between V<sub>CCO</sub> and V<sub>CCAUX</sub> must not exceed 2.625V for longer than T<sub>VCCO2VCCAUX</sub> for each power-on/off cycle to maintain device reliability levels.
- The T<sub>VCCO2VCCAUX</sub> time can be allocated in any percentage between the power-on and power-off ramps.

The recommended power-on sequence to achieve minimum current draw for the GTX transceivers is V<sub>CCINT</sub>, V<sub>MGTAVCC</sub>, V<sub>MGTAVTT</sub> OR V<sub>MGTAVCC</sub>, V<sub>CCINT</sub>, V<sub>MGTAVTT</sub>. There is no recommended sequencing for V<sub>MGTVCCAUX</sub>. Both V<sub>MGTAVCC</sub> and V<sub>CCINT</sub> can be ramped simultaneously. The recommended power-off sequence is the reverse of the power-on sequence to achieve minimum current draw.

If these recommended sequences are not met, current drawn from V<sub>MGTAVTT</sub> can be higher than specifications during power-up and power-down.

- When V<sub>MGTAVTT</sub> is powered before V<sub>MGTAVCC</sub> and V<sub>MGTAVTT</sub> - V<sub>MGTAVCC</sub> > 150 mV and V<sub>MGTAVCC</sub> < 0.7V, the V<sub>MGTAVTT</sub> current draw can increase by 460 mA per transceiver during V<sub>MGTAVCC</sub> ramp up. The duration of the current draw can be up to 0.3 x T<sub>MGTAVCC</sub> (ramp time from GND to 90% of V<sub>MGTAVCC</sub>). The reverse is true for power-down.
- When V<sub>MGTAVTT</sub> is powered before V<sub>CCINT</sub> and V<sub>MGTAVTT</sub> - V<sub>CCINT</sub> > 150 mV and V<sub>CCINT</sub> < 0.7V, the V<sub>MGTAVTT</sub> current draw can increase by 50 mA per transceiver during V<sub>CCINT</sub> ramp up. The duration of the current draw can be up to 0.3 x T<sub>VCCINT</sub> (ramp time from GND to 90% of V<sub>CCINT</sub>). The reverse is true for power-down.

Table 7 shows the minimum current, in addition to  $I_{CCQ}$ , that are required by Kintex-7 devices for proper power-on and configuration. If the current minimums shown in Table 6 and Table 7 are met, the device powers on after all five supplies have passed through their power-on reset threshold voltages. The FPGA must not be configured until after  $V_{CCINT}$  is applied.

Once initialized and configured, use the XPower tools to estimate current drain on these supplies.

**Table 7: Power-On Current for Kintex-7 Devices**

Device	$I_{CCINTMIN}$	$I_{CCAUXMIN}$	$I_{CCOMIN}$	$I_{CCAUX_IOMIN}$	$I_{CCBRAMMIN}$	Units
	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	
XC7K70T	$I_{CCINTQ} + 450$	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 40$ mA per bank	$I_{CCOAUXXIOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 40$	mA
XC7K160T	$I_{CCINTQ} + 550$	$I_{CCAUXQ} + 50$	$I_{CCOQ} + 40$ mA per bank	$I_{CCOAUXXIOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 40$	mA
XC7K325T	$I_{CCINTQ} + 600$	$I_{CCAUXQ} + 80$	$I_{CCOQ} + 40$ mA per bank	$I_{CCOAUXXIOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 40$	mA
XC7K355T	$I_{CCINTQ} + 1450$	$I_{CCAUXQ} + 109$	$I_{CCOQ} + 40$ mA per bank	$I_{CCOAUXXIOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 81$	mA
XC7K410T	$I_{CCINTQ} + 1500$	$I_{CCAUXQ} + 125$	$I_{CCOQ} + 40$ mA per bank	$I_{CCOAUXXIOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 90$	mA
XC7K420T	$I_{CCINTQ} + 2200$	$I_{CCAUXQ} + 180$	$I_{CCOQ} + 40$ mA per bank	$I_{CCOAUXXIOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 108$	mA
XC7K480T	$I_{CCINTQ} + 2200$	$I_{CCAUXQ} + 180$	$I_{CCOQ} + 40$ mA per bank	$I_{CCOAUXXIOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 108$	mA

**Notes:**

- Typical values are specified at nominal voltage, 25°C.
- Use the XPower Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate maximum power-on currents.

**Table 8: Power Supply Ramp Time**

Symbol	Description	Conditions	Min	Max	Units
$T_{VCCINT}$	Ramp time from GND to 90% of $V_{CCINT}$		0.2	50	ms
$T_{VCCO}$	Ramp time from GND to 90% of $V_{CCO}$		0.2	50	ms
$T_{VCCAUX}$	Ramp time from GND to 90% of $V_{CCAUX}$		0.2	50	ms
$T_{VCCAUX_IO}$	Ramp time from GND to 90% of $V_{CCAUX_IO}$		0.2	50	ms
$T_{VCCBRAM}$	Ramp time from GND to 90% of $V_{CCBRAM}$		0.2	50	ms
$T_{VCCO2VCCAUX}$	Allowed time per power cycle for $V_{CCO} - V_{CCAUX} > 2.625V$	$T_J = 100^{\circ}C^{(1)}$	–	500	ms
		$T_J = 85^{\circ}C^{(1)}$	–	800	
$T_{MGTAVCC}$	Ramp time from GND to 90% of $V_{MGTAVCC}$		0.2	50	ms
$T_{MGTAVTT}$	Ramp time from GND to 90% of $V_{MGTAVTT}$		0.2	50	ms
$T_{MGTVCCAUX}$	Ramp time from GND to 90% of $V_{MGTVCCAUX}$		0.2	50	ms

**Notes:**

- Based on 240,000 power cycles with nominal  $V_{CCO}$  of 3.3V or 36,500 power cycles with a worst case  $V_{CCO}$  of 3.465V.

## DC Input and Output Levels

Values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $I_{OL}$  and  $I_{OH}$  are guaranteed over the recommended operating conditions at the  $V_{OL}$  and  $V_{OH}$  test points. Only selected standards are tested. These are chosen to ensure that all standards meet their specifications. The selected standards are tested at a minimum  $V_{CCO}$  with the respective  $V_{OL}$  and  $V_{OH}$  voltage levels shown. Other standards are sample tested.

Table 9: SelectIO DC Input and Output Levels (1)(2)

I/O Standard	$V_{IL}$		$V_{IH}$		$V_{OL}$	$V_{OH}$	$I_{OL}$	$I_{OH}$
	V, Min	V, Max	V, Min	V, Max	V, Max	V, Min	mA	mA
HSTL_I	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8	-8
HSTL_I_12	-0.300	$V_{REF} - 0.080$	$V_{REF} + 0.080$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	6.3	-6.3
HSTL_I_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8	-8
HSTL_II	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16	-16
HSTL_II_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16	-16
HSUL_12	-0.300	$V_{REF} - 0.130$	$V_{REF} + 0.130$	$V_{CCO} + 0.300$	20% $V_{CCO}$	80% $V_{CCO}$	0.1	-0.1
LVC MOS12	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 3	Note 3
LVC MOS15, LVDCI_15	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	Note 4	Note 4
LVC MOS18, LVDCI_18	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.450	$V_{CCO} - 0.450$	Note 5	Note 5
LVC MOS25	-0.300	0.700	1.700	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 6	Note 6
LVC MOS33	-0.300	0.800	2.000	3.450	0.400	$V_{CCO} - 0.400$	Note 6	Note 6
LV TTL	-0.300	0.800	2.000	3.450	0.400	2.400	Note 7	Note 7
MOBILE_DDR	-0.300	20% $V_{CCO}$	80% $V_{CCO}$	$V_{CCO} + 0.300$	10% $V_{CCO}$	90% $V_{CCO}$	0.1	-0.1
PCI33_3	-0.500	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.500$	10% $V_{CCO}$	90% $V_{CCO}$	1.5	-0.5
SSTL12	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	14.25	-14.25
SSTL135	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	13.0	-13.0
SSTL135_R	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	8.9	-8.9
SSTL15	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	13.0	-13.0
SSTL15_R	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	8.9	-8.9
SSTL18_I	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.470$	$V_{CCO}/2 + 0.470$	8	-8
SSTL18_II	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.600$	$V_{CCO}/2 + 0.600$	13.4	-13.4

### Notes:

1. Tested according to relevant specifications.
2. 3.3V and 2.5V standards are only supported in 3.3V I/O banks.
3. Supported drive strengths of 2, 4, 6, or 8 mA in HP I/O banks and 4, 8, or 12 mA in HR I/O banks.
4. Supported drive strengths of 2, 4, 6, 8, 12, or 16 mA in HP I/O banks and 4, 8, 12, or 16 mA in HR I/O banks.
5. Supported drive strengths of 2, 4, 6, 8, 12, or 16 mA in HP I/O banks and 4, 8, 12, 16, or 24 mA in HR I/O banks.
6. Supported drive strengths of 4, 8, 12, or 16 mA
7. Supported drive strengths of 4, 8, 12, 16, or 24 mA
8. For detailed interface specific DC voltage levels, see [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).



Table 10: Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>			V <sub>OCM</sub> <sup>(3)</sup>			V <sub>OD</sub> <sup>(4)</sup>		
	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max
BLVDS_25	0.300	1.200	1.425	0.100	–	–	–	1.250	–	Note 5		
MINI_LVDS_25	0.300	1.200	V <sub>CCAUX</sub>	0.200	0.400	0.600	1.000	1.200	1.400	0.300	0.450	0.600
PPDS_25	0.200	0.900	V <sub>CCAUX</sub>	0.100	0.250	0.400	0.500	0.950	1.400	0.100	0.250	0.400
RSDS_25	0.300	0.900	1.500	0.100	0.350	0.600	1.000	1.200	1.400	0.100	0.350	0.600
TMDS_33	2.700	2.965	3.230	0.150	0.675	1.200	V <sub>CCO</sub> –0.405	V <sub>CCO</sub> –0.300	V <sub>CCO</sub> –0.190	0.400	0.600	0.800

Notes:

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OCM</sub> is the output common mode voltage.
4. V<sub>OD</sub> is the output differential voltage (Q –  $\bar{Q}$ ).
5. V<sub>OD</sub> for BLVDS will vary significantly depending on topology and loading.
6. LVDS\_25 is specified in Table 12.
7. LVDS is specified in Table 13.

Table 11: Complementary Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>		V <sub>OL</sub> <sup>(3)</sup>	V <sub>OH</sub> <sup>(4)</sup>	I <sub>OL</sub>	I <sub>OH</sub>
	V, Min	V, Typ	V, Max	V, Min	V, Max	V, Max	V, Min	mA, Max	mA, Min
DIFF_HSTL_I	0.300	0.750	1.125	0.100	–	0.400	V <sub>CCO</sub> –0.400	8.00	–8.00
DIFF_HSTL_I_18	0.300	0.900	1.425	0.100	–	0.400	V <sub>CCO</sub> –0.400	8.00	–8.00
DIFF_HSTL_II	0.300	0.750	1.125	0.100	–	0.400	V <sub>CCO</sub> –0.400	16.00	–16.00
DIFF_HSTL_II_18	0.300	0.900	1.425	0.100	–	0.400	V <sub>CCO</sub> –0.400	16.00	–16.00
DIFF_HSUL_12	0.300	0.600	0.850	0.100	–	20% V <sub>CCO</sub>	80% V <sub>CCO</sub>	0.100	–0.100
DIFF_MOBILE_DDR	0.300	0.900	1.425	0.100	–	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	0.100	–0.100
DIFF_SSTL12	0.300	0.600	0.850	0.100	–	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	14.25	–14.25
DIFF_SSTL135	0.300	0.675	1.000	0.100	–	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	13.0	–13.0
DIFF_SSTL135_R	0.300	0.675	1.000	0.100	–	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	8.9	–8.9
DIFF_SSTL15	0.300	0.750	1.125	0.100	–	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	13.0	–13.0
DIFF_SSTL15_R	0.300	0.750	1.125	0.100	–	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	8.9	–8.9
DIFF_SSTL18_I	0.300	0.900	1.425	0.100	–	(V <sub>CCO</sub> /2) – 0.470	(V <sub>CCO</sub> /2) + 0.470	8.00	–8.00
DIFF_SSTL18_II	0.300	0.900	1.425	0.100	–	(V <sub>CCO</sub> /2) – 0.600	(V <sub>CCO</sub> /2) + 0.600	13.4	–13.4

Notes:

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OL</sub> is the single-ended low-output voltage.
4. V<sub>OH</sub> is the single-ended high-output voltage.

## LVDS DC Specifications (LVDS\_25)

The LVDS\_25 standard is available in the HR I/O banks. See [UG471: 7 Series FPGAs SelectIO Resources User Guide](#) for more information.

Table 12: LVDS\_25 DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply Voltage		2.375	2.500	2.625	V
$V_{OH}$	Output High Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	–	–	1.675	V
$V_{OL}$	Output Low Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.700	–	–	V
$V_{ODIFF}$	Differential Output Voltage (Q – $\bar{Q}$ ), Q = High ( $\bar{Q}$ – Q), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output Common-Mode Voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.000	1.250	1.425	V
$V_{IDIFF}$	Differential Input Voltage (Q – $\bar{Q}$ ), Q = High ( $\bar{Q}$ – Q), $\bar{Q}$ = High		100	350	600	mV
$V_{ICM}$	Input Common-Mode Voltage		0.300	1.200	1.425	V

## LVDS DC Specifications (LVDS)

The LVDS standard is available in the HP I/O banks. See [UG471: 7 Series FPGAs SelectIO Resources User Guide](#) for more information.

Table 13: LVDS DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply Voltage		1.710	1.800	1.890	V
$V_{OH}$	Output High Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	–	–	1.675	V
$V_{OL}$	Output Low Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.825	–	–	V
$V_{ODIFF}$	Differential Output Voltage (Q – $\bar{Q}$ ), Q = High ( $\bar{Q}$ – Q), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output Common-Mode Voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.000	1.250	1.425	V
$V_{IDIFF}$	Differential Input Voltage (Q – $\bar{Q}$ ), Q = High ( $\bar{Q}$ – Q), $\bar{Q}$ = High	Common-mode input voltage = 1.25V	100	350	600	mV
$V_{ICM}$	Input Common-Mode Voltage	Differential input voltage = $\pm 350$ mV	0.300	1.200	1.425	V

## AC Switching Characteristics

All values represented in this data sheet are based on the speed specifications in ISE® software 14.3 v1.07 for the -3, -2, -2L(1.0V), -1, and v1.06 for -2L(0.9V) speed grades.

Switching characteristics are specified on a per-speed-grade basis and can be designated as Advance, Preliminary, or Production. Each designation is defined as follows:

### **Advance Product Specification**

These specifications are based on simulations only and are typically available soon after device design specifications are frozen. Although speed grades with this designation are considered relatively stable and conservative, some under-reporting might still occur.

### **Preliminary Product Specification**

These specifications are based on complete ES (engineering sample) silicon characterization. Devices and speed grades with this designation are intended to give a better indication of the expected performance of production silicon. The probability of under-reporting delays is greatly reduced as compared to Advance data.

### **Production Product Specification**

These specifications are released once enough production silicon of a particular device family member has been characterized to provide full correlation between specifications and devices over numerous production lots. There is no under-reporting of delays, and customers receive formal notification of any subsequent changes. Typically, the slowest speed grades transition to Production before faster speed grades.

## Testing of AC Switching Characteristics

Internal timing parameters are derived from measuring internal test patterns. All AC switching characteristics are representative of worst-case supply voltage and junction temperature conditions.

For more specific, more precise, and worst-case guaranteed data, use the values reported by the static timing analyzer and back-annotate to the simulation net list. Unless otherwise noted, values apply to all Kintex-7 FPGAs.

## Speed Grade Designations

Since individual family members are produced at different times, the migration from one category to another depends completely on the status of the fabrication process for each device. [Table 14](#) correlates the current status of each Kintex-7 device on a per speed grade basis.

Table 14: Kintex-7 Device Speed Grade Designations

Device	Speed Grade Designations		
	Advance	Preliminary	Production
XC7K70T	-2L (0.9V)		-3, -2, -2L(1.0V), -1
XC7K160T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K325T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K355T	-2L (0.9V)		-3, -2, -2L(1.0V), -1
XC7K410T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K420T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)
XC7K480T			-3, -2, -2L(1.0V), -1, and -2L (0.9V)

## Production Silicon and ISE Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases.

Table 15 lists the production released Kintex-7 device, speed grade, and the minimum corresponding supported speed specification version and ISE software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

Table 15: Kintex-7 Device Production Software and Speed Specification Release

Device	Speed Grade Designations			
	1.0V			0.9V
	-3	-2/-2L	-1	-2L
XC7K70T	ISE 14.2 v1.06			
XC7K160T	ISE 14.2 v1.06			ISE 14.3 v1.06
XC7K325T	ISE 14.2 v1.06			ISE 14.3 v1.06
XC7K355T	ISE 14.2 v1.06			
XC7K410T	ISE 14.2 v1.06			ISE 14.3 v1.06
XC7K420T	ISE 14.2 v1.06			ISE 14.3 v1.06
XC7K480T	ISE 14.2 v1.06			ISE 14.3 v1.06

**Notes:**

- Blank entries indicate a device and/or speed grade in advance or preliminary status.

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Kintex-7 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the AC Switching Characteristics, page 11. In each table, the I/O bank type is either High Performance (HP) or High Range (HR).

Table 16: Networking Applications Interface Performances

Description	I/O Bank Type	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
SDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 8)	HR	710	710	625	625	Mb/s
	HP	710	710	625	625	Mb/s
DDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 14)	HR	1250	1250	950	950	Mb/s
	HP	1600	1400	1250	1250	Mb/s
SDR LVDS receiver (SFI-4.1) <sup>(1)</sup>	HR	710	710	625	625	Mb/s
	HP	710	710	625	625	Mb/s
DDR LVDS receiver (SPI-4.2) <sup>(1)</sup>	HR	1250	1250	950	950	Mb/s
	HP	1600	1400	1250	1250	Mb/s

**Notes:**

- LVDS receivers are typically bounded with certain applications where specific dynamic phase-alignment (DPA) algorithms dominate deterministic performance.

Table 17: Maximum Physical Interface (PHY) Rate for Memory Interfaces (FFG Packages)<sup>(1)(2)</sup>

Memory Standard	I/O Bank Type	V <sub>CCAUX_IO</sub>	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
<b>4:1 Memory Controllers</b>							
DDR3	HP	2.0V	1866	1866	1600	1333	Mb/s
	HP	1.8V	1600	1333	1066	1066	Mb/s
	HR	N/A	1066	1066	800	800	Mb/s
DDR3L	HP	2.0V	1600	1600	1333	1066	Mb/s
	HP	1.8V	1333	1066	800	800	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	2.0V	800	800	800	800	Mb/s
	HP	1.8V	800	800	800	800	Mb/s
	HR	N/A	800	800	800	800	Mb/s
RLDRAM III <sup>(3)</sup>	HP	2.0V	800	667	667	533	MHz
	HP	1.8V	550	500	450	450	MHz
	HR	N/A	N/A				
<b>2:1 Memory Controllers</b>							
DDR3	HP	2.0V	1066	1066	800	800	Mb/s
	HP	1.8V	1066	1066	800	800	Mb/s
	HR	N/A	1066	1066	800	800	Mb/s
DDR3L	HP	2.0V	1066	1066	800	800	Mb/s
	HP	1.8V	1066	1066	800	800	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	2.0V	800	800	800	800	Mb/s
	HP	1.8V					
	HR	N/A					
QDR II+ <sup>(4)</sup>	HP	2.0V	550	500	450	450	MHz
	HP	1.8V					
	HR	N/A					
RLDRAM II	HP	2.0V	533	500	450	450	MHz
	HP	1.8V					
	HR	N/A					
LPDDR2 <sup>(3)</sup>	HP	2.0V	800	800	800	800	Mb/s
	HP	1.8V	800	800	800	800	Mb/s
	HR	N/A	800	667	667	667	Mb/s

**Notes:**

1. V<sub>REF</sub> tracking is required. For more information, see [UG586](#), 7 Series FPGAs Memory Interface Solutions User Guide.
2. When using the internal V<sub>REF</sub> the maximum data rate is 800 Mb/s (400 MHz).
3. RLDRAM III (BL = 4, BL = 8) and LPDDR2 specifications have not been validated with memory IP.
4. The maximum QDRII+ performance specifications are for burst-length 4 (BL = 4) implementations. Burst length 2 (BL = 2) implementations are limited to 333 MHz for all speed grades and I/O bank types.

Table 18: Maximum Physical Interface (PHY) Rate for Memory Interfaces (FBG Packages)<sup>(1)(2)</sup>

Memory Standard	I/O Bank Type	V <sub>CCAUX_IO</sub> <sup>(3)</sup>	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
<b>4:1 Memory Controllers</b>							
DDR3	HP	N/A	1333	1066	800	800	Mb/s
	HR	N/A	1066	800	800	800	Mb/s
DDR3L	HP	N/A	1066	800	667	667	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	N/A	800	800	800	800	Mb/s
	HR	N/A	800	667	667	667	Mb/s
RLDRAM III <sup>(4)</sup>	HP	N/A	550	500	450	450	MHz
	HR	N/A	N/A				
<b>2:1 Memory Controllers</b>							
DDR3	HP	N/A	1066	1066	800	800	Mb/s
	HR	N/A	1066	800	800	800	Mb/s
DDR3L	HP	N/A	1066	800	667	667	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	N/A	800	800	800	800	Mb/s
	HR	N/A	800	667	667	667	Mb/s
QDR II+ <sup>(5)</sup>	HP	N/A	550	500	450	450	MHz
	HR	N/A	450	400	350	350	MHz
RLDRAM II	HP	N/A	533	500	450	450	MHz
	HR	N/A					
LPDDR2 <sup>(4)</sup>	HP	N/A	667	667	667	667	Mb/s
	HR	N/A	667	667	533	533	Mb/s

**Notes:**

1. V<sub>REF</sub> tracking is required. For more information, see [UG586](#), *7 Series FPGAs Memory Interface Solutions User Guide*.
2. When using the internal V<sub>REF</sub> the maximum data rate is 800 Mb/s (400 MHz).
3. FBG packages do not have separate V<sub>CCAUX\_IO</sub> supply pins to adjust the pre-driver voltage of the HP I/O banks.
4. RLDRAM III (BL = 4, BL = 8) and LPDDR2 specifications have not been validated with memory IP.
5. The maximum QDRII+ performance specifications are for burst-length 4 (BL = 4) implementations. Burst length 2 (BL = 2) implementations are limited to 333 MHz for all speed grades and I/O bank types.

### IOB Pad Input/Output/3-State

Table 19 (3.3V high-range IOB (HR)) and Table 20 (1.8V high-performance IOB (HP)) summarizes the values of standard-specific data input delay adjustments, output delays terminating at pads (based on standard) and 3-state delays.

- $T_{IOPI}$  is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.
- $T_{IOOP}$  is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.
- $T_{IOTP}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer. In HP I/O banks, the internal DCI termination turn-on time is always faster than  $T_{IOTP}$  when the DCITERMDISABLE pin is used. In HR I/O banks, the IN\_TERM termination turn-on time is always faster than  $T_{IOTP}$  when the INTERMDISABLE pin is used.

Table 19: 3.3V IOB High Range (HR) Switching Characteristics

I/O Standard	$T_{IOPI}$				$T_{IOOP}$				$T_{IOTP}$				Units
	Speed Grade				Speed Grade				Speed Grade				
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V		
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	
LVTTTL_S4	1.31	1.42	1.64	1.51	5.27	5.63	6.05	4.13	6.03	6.49	7.04	4.64	ns
LVTTTL_S8	1.31	1.42	1.64	1.51	4.45	4.83	5.30	3.86	5.21	5.69	6.29	4.38	ns
LVTTTL_S12	1.31	1.42	1.64	1.51	4.45	4.83	5.29	3.84	5.21	5.69	6.28	4.36	ns
LVTTTL_S16	1.31	1.42	1.64	1.51	3.47	3.88	4.40	3.39	4.23	4.74	5.39	3.91	ns
LVTTTL_S24	1.31	1.42	1.64	1.51	3.58	3.99	4.51	3.61	4.34	4.85	5.50	4.13	ns
LVTTTL_F4	1.31	1.42	1.64	1.51	4.70	4.98	5.29	3.58	5.46	5.84	6.28	4.09	ns
LVTTTL_F8	1.31	1.42	1.64	1.51	3.66	4.06	4.56	3.06	4.42	4.92	5.55	3.58	ns
LVTTTL_F12	1.31	1.42	1.64	1.51	3.66	4.06	4.56	3.05	4.42	4.92	5.55	3.56	ns
LVTTTL_F16	1.31	1.42	1.64	1.51	2.57	2.85	3.15	2.88	3.33	3.71	4.14	3.39	ns
LVTTTL_F24	1.31	1.42	1.64	1.51	2.41	2.64	2.89	2.94	3.17	3.50	3.88	3.45	ns
LVDS_25 <sup>(1)</sup>	0.64	0.68	0.80	0.83	1.36	1.47	1.55	1.58	2.12	2.33	2.54	2.09	ns
MINI_LVDS_25	0.68	0.70	0.79	0.83	1.36	1.47	1.55	1.59	2.12	2.33	2.54	2.11	ns
BLVDS_25 <sup>(1)</sup>	0.65	0.69	0.80	0.83	1.83	2.02	2.20	2.16	2.59	2.88	3.19	2.67	ns
RSDS_25 (point to point) <sup>(1)</sup>	0.63	0.68	0.79	0.83	1.36	1.48	1.55	1.59	2.12	2.34	2.54	2.11	ns
PPDS_25 <sup>(1)</sup>	0.65	0.69	0.80	0.83	1.36	1.49	1.58	1.59	2.12	2.35	2.57	2.11	ns
TMDS_33 <sup>(1)</sup>	0.72	0.76	0.86	0.83	1.43	1.54	1.60	1.70	2.19	2.40	2.59	2.22	ns
PCI33_3 <sup>(1)</sup>	1.28	1.41	1.65	1.50	2.71	3.08	3.52	3.42	3.47	3.94	4.51	3.94	ns
HSUL_12	0.63	0.64	0.71	0.79	2.06	2.31	2.59	2.13	2.82	3.17	3.58	2.64	ns
DIFF_HSUL_12	0.58	0.61	0.70	0.81	1.83	2.04	2.26	1.92	2.59	2.90	3.25	2.44	ns
HSTL_I_S	0.61	0.64	0.73	0.79	1.55	1.69	1.80	1.91	2.31	2.55	2.79	2.42	ns
HSTL_II_S	0.61	0.64	0.73	0.78	1.21	1.34	1.43	1.70	1.97	2.20	2.42	2.22	ns
HSTL_I_18_S	0.64	0.67	0.76	0.79	1.28	1.39	1.45	1.58	2.04	2.25	2.44	2.09	ns
HSTL_II_18_S	0.64	0.67	0.76	0.79	1.18	1.31	1.40	1.69	1.94	2.17	2.39	2.20	ns
DIFF_HSTL_I_S	0.63	0.67	0.77	0.78	1.42	1.54	1.61	1.84	2.18	2.40	2.60	2.36	ns
DIFF_HSTL_II_S	0.63	0.67	0.77	0.79	1.15	1.24	1.27	1.78	1.91	2.10	2.26	2.30	ns
DIFF_HSTL_I_18_S	0.65	0.69	0.78	0.79	1.27	1.38	1.43	1.67	2.03	2.24	2.42	2.19	ns
DIFF_HSTL_II_18_S	0.65	0.69	0.78	0.81	1.14	1.23	1.26	1.72	1.90	2.09	2.25	2.23	ns

**Table 19: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)**

I/O Standard	T <sub>IOP1</sub>				T <sub>IOP</sub>				T <sub>IOTP</sub>				Units
	Speed Grade				Speed Grade				Speed Grade				
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V		
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	
HSTL_I_F	0.61	0.64	0.73	0.79	1.10	1.19	1.23	1.41	1.86	2.05	2.22	1.92	ns
HSTL_II_F	0.61	0.64	0.73	0.78	1.05	1.18	1.28	1.42	1.81	2.04	2.27	1.94	ns
HSTL_I_18_F	0.64	0.67	0.76	0.79	1.05	1.18	1.28	1.44	1.81	2.04	2.27	1.95	ns
HSTL_II_18_F	0.64	0.67	0.76	0.79	1.03	1.14	1.23	1.42	1.79	2.00	2.22	1.94	ns
DIFF_HSTL_I_F	0.63	0.67	0.77	0.78	1.09	1.18	1.22	1.48	1.85	2.04	2.21	2.00	ns
DIFF_HSTL_II_F	0.63	0.67	0.77	0.79	1.02	1.11	1.14	1.48	1.78	1.97	2.13	2.00	ns
DIFF_HSTL_I_18_F	0.65	0.69	0.78	0.79	1.08	1.17	1.21	1.48	1.84	2.03	2.20	2.00	ns
DIFF_HSTL_II_18_F	0.65	0.69	0.78	0.81	1.01	1.10	1.13	1.48	1.77	1.96	2.12	2.00	ns
LVC MOS33_S4	1.31	1.40	1.60	1.54	5.23	5.61	6.09	4.13	5.99	6.47	7.08	4.64	ns
LVC MOS33_S8	1.31	1.40	1.60	1.54	4.46	4.85	5.33	3.84	5.22	5.71	6.32	4.36	ns
LVC MOS33_S12	1.31	1.40	1.60	1.54	3.46	3.89	4.42	3.41	4.22	4.75	5.41	3.92	ns
LVC MOS33_S16	1.31	1.40	1.60	1.54	3.06	3.43	3.88	3.72	3.82	4.29	4.87	4.23	ns
LVC MOS33_F4	1.31	1.40	1.60	1.54	4.70	5.01	5.36	3.58	5.46	5.87	6.35	4.09	ns
LVC MOS33_F8	1.31	1.40	1.60	1.54	3.62	4.04	4.56	3.06	4.38	4.90	5.55	3.58	ns
LVC MOS33_F12	1.31	1.40	1.60	1.54	2.57	2.85	3.15	2.88	3.33	3.71	4.14	3.39	ns
LVC MOS33_F16	1.31	1.40	1.60	1.54	2.44	2.69	2.96	2.88	3.20	3.55	3.95	3.39	ns
LVC MOS25_S4	1.08	1.16	1.32	1.36	4.49	4.80	5.16	3.44	5.25	5.66	6.15	3.95	ns
LVC MOS25_S8	1.08	1.16	1.32	1.36	3.66	4.04	4.49	3.20	4.42	4.90	5.48	3.72	ns
LVC MOS25_S12	1.08	1.16	1.32	1.36	2.77	3.10	3.49	2.80	3.53	3.96	4.48	3.31	ns
LVC MOS25_S16	1.08	1.16	1.32	1.36	3.24	3.62	4.09	3.14	4.00	4.48	5.08	3.66	ns
LVC MOS25_F4	1.08	1.16	1.32	1.36	3.96	4.31	4.72	3.06	4.72	5.17	5.71	3.58	ns
LVC MOS25_F8	1.08	1.16	1.32	1.36	2.43	2.87	3.42	2.50	3.19	3.73	4.41	3.02	ns
LVC MOS25_F12	1.08	1.16	1.32	1.36	2.23	2.63	3.13	2.48	2.99	3.49	4.12	3.00	ns
LVC MOS25_F16	1.08	1.16	1.32	1.36	1.92	2.17	2.45	2.33	2.68	3.03	3.44	2.84	ns
LVC MOS18_S4	0.64	0.66	0.74	0.87	3.24	3.45	3.66	1.91	4.00	4.31	4.65	2.42	ns
LVC MOS18_S8	0.64	0.66	0.74	0.87	2.58	2.91	3.31	2.50	3.34	3.77	4.30	3.02	ns
LVC MOS18_S12	0.64	0.66	0.74	0.87	2.58	2.91	3.31	2.50	3.34	3.77	4.30	3.02	ns
LVC MOS18_S16	0.64	0.66	0.74	0.87	1.82	2.03	2.24	1.84	2.58	2.89	3.23	2.36	ns
LVC MOS18_S24 <sup>(1)</sup>	0.64	0.66	0.74	0.87	1.74	1.92	2.08	1.92	2.50	2.78	3.07	2.44	ns
LVC MOS18_F4	0.64	0.66	0.74	0.87	3.12	3.31	3.49	1.77	3.88	4.17	4.48	2.28	ns
LVC MOS18_F8	0.64	0.66	0.74	0.87	1.91	2.13	2.36	2.00	2.67	2.99	3.35	2.52	ns
LVC MOS18_F12	0.64	0.66	0.74	0.87	1.91	2.13	2.36	2.00	2.67	2.99	3.35	2.52	ns
LVC MOS18_F16	0.64	0.66	0.74	0.87	1.52	1.68	1.81	1.72	2.28	2.54	2.80	2.23	ns
LVC MOS18_F24 <sup>(1)</sup>	0.64	0.66	0.74	0.87	1.34	1.46	1.55	1.66	2.10	2.32	2.54	2.17	ns
LVC MOS15_S4	0.66	0.69	0.81	0.90	3.48	3.74	4.03	2.22	4.24	4.60	5.02	2.73	ns
LVC MOS15_S8	0.66	0.69	0.81	0.90	2.37	2.67	3.01	2.41	3.13	3.53	4.00	2.92	ns
LVC MOS15_S12	0.66	0.69	0.81	0.90	1.83	2.03	2.23	1.91	2.59	2.89	3.22	2.42	ns



**Table 19: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)**

I/O Standard	T <sub>IOP1</sub>				T <sub>IOP</sub>				T <sub>IOTP</sub>				Units
	Speed Grade				Speed Grade				Speed Grade				
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V		
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	
LVC MOS15_S16	0.66	0.69	0.81	0.90	1.76	1.95	2.13	1.91	2.52	2.81	3.12	2.42	ns
LVC MOS15_F4	0.66	0.69	0.81	0.90	3.39	3.60	3.80	1.98	4.15	4.46	4.79	2.50	ns
LVC MOS15_F8	0.66	0.69	0.81	0.90	1.79	1.99	2.18	1.92	2.55	2.85	3.17	2.44	ns
LVC MOS15_F12	0.66	0.69	0.81	0.90	1.40	1.54	1.65	1.67	2.16	2.40	2.64	2.19	ns
LVC MOS15_F16	0.66	0.69	0.81	0.90	1.37	1.51	1.61	1.66	2.13	2.37	2.60	2.17	ns
LVC MOS12_S4	0.88	0.91	1.00	1.01	3.85	4.22	4.69	2.89	4.61	5.08	5.68	3.41	ns
LVC MOS12_S8	0.88	0.91	1.00	1.01	2.52	2.96	3.52	2.41	3.28	3.82	4.51	2.92	ns
LVC MOS12_S12 <sup>(1)</sup>	0.88	0.91	1.00	1.01	2.06	2.31	2.59	2.11	2.82	3.17	3.58	2.63	ns
LVC MOS12_F4	0.88	0.91	1.00	1.01	3.44	3.73	4.06	2.30	4.20	4.59	5.05	2.81	ns
LVC MOS12_F8	0.88	0.91	1.00	1.01	1.72	2.04	2.40	1.86	2.48	2.90	3.39	2.38	ns
LVC MOS12_F12 <sup>(1)</sup>	0.88	0.91	1.00	1.01	1.54	1.71	1.87	1.69	2.30	2.57	2.86	2.20	ns
SSTL135_S	0.61	0.64	0.73	0.79	1.27	1.40	1.50	1.64	2.03	2.26	2.49	2.16	ns
SSTL15_S	0.61	0.64	0.73	0.73	1.24	1.37	1.47	1.59	2.00	2.23	2.46	2.11	ns
SSTL18_I_S	0.64	0.67	0.76	0.79	1.59	1.74	1.85	1.95	2.35	2.60	2.84	2.47	ns
SSTL18_II_S	0.64	0.67	0.76	0.78	1.27	1.40	1.50	1.63	2.03	2.26	2.49	2.14	ns
DIFF_SSTL135_S	0.59	0.61	0.73	0.79	1.27	1.40	1.50	1.64	2.03	2.26	2.49	2.16	ns
DIFF_SSTL15_S	0.63	0.67	0.77	0.79	1.24	1.37	1.47	1.59	2.00	2.23	2.46	2.11	ns
DIFF_SSTL18_I_S	0.65	0.69	0.78	0.79	1.50	1.63	1.72	1.95	2.26	2.49	2.71	2.47	ns
DIFF_SSTL18_II_S	0.65	0.69	0.78	0.79	1.13	1.22	1.25	1.66	1.89	2.08	2.24	2.17	ns
SSTL135_F	0.61	0.64	0.73	0.79	1.04	1.17	1.26	1.42	1.80	2.03	2.25	1.94	ns
SSTL15_F	0.61	0.64	0.73	0.73	1.04	1.17	1.26	1.39	1.80	2.03	2.25	1.91	ns
SSTL18_I_F	0.64	0.67	0.76	0.79	1.12	1.22	1.26	1.44	1.88	2.08	2.25	1.95	ns
SSTL18_II_F	0.64	0.67	0.76	0.78	1.05	1.18	1.28	1.42	1.81	2.04	2.27	1.94	ns
DIFF_SSTL135_F	0.59	0.61	0.73	0.79	1.04	1.17	1.26	1.42	1.80	2.03	2.25	1.94	ns
DIFF_SSTL15_F	0.63	0.67	0.77	0.79	1.04	1.17	1.26	1.39	1.80	2.03	2.25	1.91	ns
DIFF_SSTL18_I_F	0.65	0.69	0.78	0.79	1.10	1.19	1.23	1.52	1.86	2.05	2.22	2.03	ns
DIFF_SSTL18_II_F	0.65	0.69	0.78	0.79	1.02	1.10	1.14	1.50	1.78	1.96	2.13	2.02	ns

**Notes:**

1. This I/O standard is only available in the 3.3V high-range (HR) banks.

**Table 20: 1.8V IOB High Performance (HP) Switching Characteristics**

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units
	Speed Grade				Speed Grade				Speed Grade				
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V		
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	
LVDS	0.75	0.79	0.92	0.89	1.05	1.17	1.24	1.43	1.68	1.92	2.06	2.04	ns
HSUL_12	0.69	0.72	0.82	0.95	1.65	1.84	2.05	1.80	2.29	2.59	2.87	2.41	ns
DIFF_HSUL_12	0.69	0.72	0.82	0.92	1.65	1.84	2.05	1.47	2.29	2.59	2.87	2.08	ns
HSTL_I_S	0.68	0.72	0.82	0.84	1.15	1.28	1.38	1.46	1.79	2.03	2.20	2.07	ns
HSTL_II_S	0.68	0.72	0.82	0.84	1.05	1.17	1.26	1.44	1.69	1.93	2.08	2.05	ns
HSTL_I_18_S	0.70	0.72	0.82	0.86	1.12	1.24	1.34	1.41	1.75	2.00	2.16	2.02	ns
HSTL_II_18_S	0.70	0.72	0.82	0.86	1.06	1.18	1.26	1.44	1.70	1.94	2.08	2.05	ns
HSTL_I_12_S	0.68	0.72	0.82	0.94	1.14	1.27	1.37	1.43	1.78	2.02	2.20	2.04	ns
HSTL_I_DCI_S	0.68	0.72	0.82	0.78	1.11	1.23	1.33	1.36	1.74	1.99	2.15	1.98	ns
HSTL_II_DCI_S	0.68	0.72	0.82	0.78	1.05	1.17	1.26	1.33	1.69	1.93	2.08	1.94	ns
HSTL_II_T_DCI_S	0.70	0.72	0.82	0.76	1.15	1.28	1.38	1.40	1.78	2.03	2.20	2.01	ns
HSTL_I_DCI_18_S	0.70	0.72	0.82	0.76	1.11	1.23	1.33	1.36	1.74	1.99	2.15	1.98	ns
HSTL_II_DCI_18_S	0.70	0.72	0.82	0.76	1.05	1.16	1.24	1.32	1.69	1.92	2.06	1.93	ns
HSTL_II_T_DCI_18_S	0.70	0.72	0.82	0.76	1.11	1.23	1.33	1.36	1.74	1.99	2.15	1.98	ns
DIFF_HSTL_I_S	0.75	0.79	0.92	0.89	1.15	1.28	1.38	1.47	1.79	2.03	2.20	2.08	ns
DIFF_HSTL_II_S	0.75	0.79	0.92	0.89	1.05	1.17	1.26	1.47	1.69	1.93	2.08	2.08	ns
DIFF_HSTL_I_DCI_S	0.75	0.79	0.92	0.76	1.15	1.28	1.38	1.47	1.78	2.03	2.20	2.08	ns
DIFF_HSTL_II_DCI_S	0.75	0.79	0.92	0.76	1.05	1.17	1.26	1.40	1.69	1.93	2.08	2.01	ns
DIFF_HSTL_I_18_S	0.75	0.79	0.92	0.89	1.12	1.24	1.34	1.46	1.75	2.00	2.16	2.07	ns
DIFF_HSTL_II_18_S	0.75	0.79	0.92	0.89	1.06	1.18	1.26	1.47	1.70	1.94	2.08	2.08	ns
DIFF_HSTL_I_DCI_18_S	0.75	0.79	0.92	0.75	1.11	1.23	1.33	1.46	1.74	1.99	2.15	2.07	ns
DIFF_HSTL_II_DCI_18_S	0.75	0.79	0.92	0.75	1.05	1.16	1.24	1.41	1.69	1.92	2.06	2.02	ns
DIFF_HSTL_II_T_DCI_18_S	0.75	0.79	0.92	0.76	1.11	1.23	1.33	1.46	1.74	1.99	2.15	2.07	ns
HSTL_I_F	0.68	0.72	0.82	0.84	1.02	1.14	1.22	1.26	1.66	1.90	2.04	1.87	ns
HSTL_II_F	0.68	0.72	0.82	0.84	0.97	1.08	1.15	1.29	1.61	1.84	1.97	1.90	ns
HSTL_I_18_F	0.70	0.72	0.82	0.86	1.04	1.16	1.24	1.32	1.68	1.91	2.06	1.93	ns
HSTL_II_18_F	0.70	0.72	0.82	0.86	0.98	1.09	1.16	1.35	1.62	1.85	1.98	1.96	ns
HSTL_I_12_F	0.68	0.72	0.82	0.94	1.02	1.13	1.21	1.26	1.65	1.88	2.03	1.87	ns
HSTL_I_DCI_F	0.68	0.72	0.82	0.78	1.04	1.16	1.24	1.30	1.67	1.91	2.06	1.91	ns
HSTL_II_DCI_F	0.68	0.72	0.82	0.78	0.97	1.08	1.15	1.22	1.61	1.84	1.97	1.83	ns
HSTL_II_T_DCI_F	0.70	0.72	0.82	0.76	1.02	1.14	1.22	1.26	1.66	1.90	2.04	1.87	ns
HSTL_I_DCI_18_F	0.70	0.72	0.82	0.76	1.04	1.16	1.24	1.30	1.67	1.91	2.06	1.91	ns
HSTL_II_DCI_18_F	0.70	0.72	0.82	0.76	0.98	1.09	1.16	1.27	1.61	1.85	1.98	1.88	ns
HSTL_II_T_DCI_18_F	0.70	0.72	0.82	0.76	1.04	1.16	1.24	1.30	1.67	1.91	2.06	1.91	ns
DIFF_HSTL_I_F	0.75	0.79	0.92	0.89	1.02	1.14	1.22	1.35	1.66	1.90	2.04	1.96	ns
DIFF_HSTL_II_F	0.75	0.79	0.92	0.89	0.97	1.08	1.15	1.35	1.61	1.84	1.97	1.96	ns
DIFF_HSTL_I_DCI_F	0.75	0.79	0.92	0.76	1.02	1.14	1.22	1.35	1.66	1.90	2.04	1.96	ns

**Table 20: 1.8V IOB High Performance (HP) Switching Characteristics (Cont'd)**

I/O Standard	T <sub>IOP1</sub>				T <sub>IOP</sub>				T <sub>IOTP</sub>				Units
	Speed Grade				Speed Grade				Speed Grade				
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V		
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	
DIFF_HSTL_II_DCI_F	0.75	0.79	0.92	0.76	0.97	1.08	1.15	1.30	1.61	1.84	1.97	1.91	ns
DIFF_HSTL_I_18_F	0.75	0.79	0.92	0.89	1.04	1.16	1.24	1.38	1.68	1.91	2.06	1.99	ns
DIFF_HSTL_II_18_F	0.75	0.79	0.92	0.89	0.98	1.09	1.16	1.40	1.62	1.85	1.98	2.01	ns
DIFF_HSTL_I_DCI_18_F	0.75	0.79	0.92	0.75	1.04	1.16	1.24	1.38	1.67	1.91	2.06	1.99	ns
DIFF_HSTL_II_DCI_18_F	0.75	0.79	0.92	0.75	0.98	1.09	1.16	1.33	1.61	1.85	1.98	1.94	ns
DIFF_HSTL_II_T_DCI_18_F	0.75	0.79	0.92	0.76	1.04	1.16	1.24	1.38	1.67	1.91	2.06	1.99	ns
LVC MOS18_S2	0.47	0.50	0.60	0.87	3.95	4.28	4.85	3.40	4.59	5.04	5.67	4.01	ns
LVC MOS18_S4	0.47	0.50	0.60	0.87	2.67	2.98	3.43	2.69	3.31	3.73	4.26	3.30	ns
LVC MOS18_S6	0.47	0.50	0.60	0.87	2.14	2.38	2.72	2.18	2.77	3.14	3.54	2.79	ns
LVC MOS18_S8	0.47	0.50	0.60	0.87	1.98	2.21	2.52	2.02	2.61	2.97	3.35	2.63	ns
LVC MOS18_S12	0.47	0.50	0.60	0.87	1.70	1.91	2.17	1.85	2.34	2.67	2.99	2.46	ns
LVC MOS18_S16	0.47	0.50	0.60	0.87	1.57	1.75	1.97	1.76	2.20	2.51	2.79	2.37	ns
LVC MOS18_F2	0.47	0.50	0.60	0.87	3.50	3.87	4.48	2.85	4.14	4.63	5.30	3.46	ns
LVC MOS18_F4	0.47	0.50	0.60	0.87	2.23	2.50	2.87	2.26	2.87	3.25	3.69	2.87	ns
LVC MOS18_F6	0.47	0.50	0.60	0.87	1.80	2.00	2.26	1.52	2.43	2.76	3.08	2.13	ns
LVC MOS18_F8	0.47	0.50	0.60	0.87	1.46	1.72	2.04	1.51	2.10	2.47	2.86	2.12	ns
LVC MOS18_F12	0.47	0.50	0.60	0.87	1.26	1.40	1.53	1.46	1.89	2.16	2.35	2.07	ns
LVC MOS18_F16	0.47	0.50	0.60	0.87	1.19	1.33	1.44	1.46	1.83	2.08	2.26	2.07	ns
LVC MOS15_S2	0.59	0.62	0.73	0.86	3.55	3.89	4.45	3.11	4.19	4.65	5.27	3.73	ns
LVC MOS15_S4	0.59	0.62	0.73	0.86	2.45	2.70	3.06	2.46	3.08	3.45	3.89	3.07	ns
LVC MOS15_S6	0.59	0.62	0.73	0.86	2.24	2.51	2.88	2.33	2.88	3.26	3.71	2.94	ns
LVC MOS15_S8	0.59	0.62	0.73	0.86	1.91	2.16	2.49	2.05	2.55	2.91	3.31	2.66	ns
LVC MOS15_S12	0.59	0.62	0.73	0.86	1.77	1.98	2.23	1.97	2.41	2.73	3.05	2.58	ns
LVC MOS15_S16	0.59	0.62	0.73	0.86	1.62	1.81	2.02	1.85	2.26	2.56	2.84	2.46	ns
LVC MOS15_F2	0.59	0.62	0.73	0.86	3.38	3.69	4.18	2.74	4.02	4.44	5.00	3.35	ns
LVC MOS15_F4	0.59	0.62	0.73	0.86	2.04	2.21	2.44	1.72	2.68	2.97	3.26	2.33	ns
LVC MOS15_F6	0.59	0.62	0.73	0.86	1.47	1.74	2.09	1.49	2.10	2.50	2.91	2.10	ns
LVC MOS15_F8	0.59	0.62	0.73	0.86	1.31	1.46	1.61	1.47	1.95	2.22	2.43	2.08	ns
LVC MOS15_F12	0.59	0.62	0.73	0.86	1.21	1.34	1.45	1.44	1.84	2.10	2.27	2.05	ns
LVC MOS15_F16	0.59	0.62	0.73	0.86	1.18	1.31	1.41	1.41	1.82	2.07	2.23	2.02	ns
LVC MOS12_S2	0.64	0.67	0.78	0.95	3.38	3.80	4.48	3.27	4.02	4.55	5.30	3.88	ns
LVC MOS12_S4	0.64	0.67	0.78	0.95	2.62	2.94	3.43	2.76	3.26	3.70	4.25	3.37	ns
LVC MOS12_S6	0.64	0.67	0.78	0.95	2.05	2.33	2.72	2.24	2.69	3.08	3.54	2.85	ns
LVC MOS12_S8	0.64	0.67	0.78	0.95	1.94	2.18	2.51	2.16	2.58	2.94	3.33	2.77	ns
LVC MOS12_F2	0.64	0.67	0.78	0.95	2.84	3.15	3.62	2.47	3.48	3.90	4.44	3.08	ns
LVC MOS12_F4	0.64	0.67	0.78	0.95	1.97	2.18	2.44	1.69	2.61	2.93	3.26	2.30	ns
LVC MOS12_F6	0.64	0.67	0.78	0.95	1.33	1.51	1.70	1.43	1.96	2.26	2.52	2.04	ns

**Table 20: 1.8V IOB High Performance (HP) Switching Characteristics (Cont'd)**

I/O Standard	T <sub>IOP1</sub>				T <sub>IOP</sub>				T <sub>IOTP</sub>				Units
	Speed Grade				Speed Grade				Speed Grade				
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V		
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	
LVC MOS12_F8	0.64	0.67	0.78	0.95	1.27	1.42	1.55	1.41	1.91	2.18	2.37	2.02	ns
LVDCI_18	0.47	0.50	0.60	0.86	1.99	2.15	2.35	2.44	2.62	2.91	3.17	3.05	ns
LVDCI_15	0.59	0.62	0.73	0.87	1.98	2.23	2.58	2.40	2.62	2.99	3.40	3.01	ns
LVDCI_DV2_18	0.47	0.50	0.60	0.87	1.99	2.15	2.34	1.86	2.62	2.90	3.17	2.48	ns
LVDCI_DV2_15	0.59	0.62	0.73	0.87	1.98	2.23	2.58	1.83	2.62	2.99	3.40	2.44	ns
HSLVDCI_18	0.68	0.72	0.82	0.86	1.99	2.15	2.35	2.43	2.62	2.91	3.17	3.04	ns
HSLVDCI_15	0.68	0.72	0.82	0.84	1.98	2.23	2.58	2.27	2.62	2.99	3.40	2.88	ns
SSTL18_I_S	0.68	0.72	0.82	0.86	1.02	1.15	1.24	1.41	1.66	1.90	2.07	2.02	ns
SSTL18_II_S	0.68	0.72	0.82	0.87	1.17	1.29	1.37	1.55	1.81	2.05	2.19	2.16	ns
SSTL18_I_DCI_S	0.68	0.72	0.82	0.76	0.92	1.06	1.17	1.32	1.56	1.82	1.99	1.93	ns
SSTL18_II_DCI_S	0.68	0.72	0.82	0.78	0.88	0.98	1.08	1.26	1.51	1.74	1.90	1.87	ns
SSTL18_II_T_DCI_S	0.68	0.72	0.82	0.78	0.92	1.06	1.17	1.32	1.56	1.82	1.99	1.93	ns
SSTL15_S	0.68	0.72	0.82	0.81	0.94	1.06	1.15	1.32	1.58	1.82	1.97	1.93	ns
SSTL15_DCI_S	0.68	0.72	0.82	0.78	0.94	1.06	1.15	1.30	1.57	1.82	1.97	1.91	ns
SSTL15_T_DCI_S	0.68	0.72	0.82	0.80	0.94	1.06	1.15	1.30	1.57	1.82	1.97	1.91	ns
SSTL135_S	0.69	0.72	0.82	0.89	0.97	1.10	1.19	1.35	1.60	1.85	2.01	1.96	ns
SSTL135_DCI_S	0.69	0.72	0.82	0.84	0.97	1.09	1.19	1.33	1.60	1.85	2.01	1.94	ns
SSTL135_T_DCI_S	0.69	0.72	0.82	0.84	0.97	1.09	1.19	1.33	1.60	1.85	2.01	1.94	ns
SSTL12_S	0.69	0.72	0.82	0.95	0.96	1.09	1.18	1.33	1.60	1.84	2.00	1.94	ns
SSTL12_DCI_S	0.69	0.72	0.82	0.91	1.03	1.17	1.27	1.33	1.66	1.92	2.09	1.94	ns
SSTL12_T_DCI_S	0.69	0.72	0.82	0.91	1.03	1.17	1.27	1.33	1.66	1.92	2.09	1.94	ns
DIFF_SSTL18_I_S	0.75	0.79	0.92	0.89	1.02	1.15	1.24	1.43	1.66	1.90	2.07	2.04	ns
DIFF_SSTL18_II_S	0.75	0.79	0.92	0.89	1.17	1.29	1.37	1.55	1.81	2.05	2.19	2.16	ns
DIFF_SSTL18_I_DCI_S	0.75	0.79	0.92	0.76	0.92	1.06	1.17	1.40	1.56	1.82	1.99	2.01	ns
DIFF_SSTL18_II_DCI_S	0.75	0.79	0.92	0.75	0.88	0.98	1.08	1.33	1.51	1.74	1.90	1.94	ns
DIFF_SSTL18_II_T_DCI_S	0.75	0.79	0.92	0.76	0.92	1.06	1.17	1.40	1.56	1.82	1.99	2.01	ns
DIFF_SSTL15_S	0.68	0.72	0.82	0.89	0.94	1.06	1.15	1.32	1.58	1.82	1.97	1.93	ns
DIFF_SSTL15_DCI_S	0.68	0.72	0.82	0.75	0.94	1.06	1.15	1.30	1.57	1.82	1.97	1.91	ns
DIFF_SSTL15_T_DCI_S	0.68	0.72	0.82	0.76	0.94	1.06	1.15	1.38	1.57	1.82	1.97	1.99	ns
DIFF_SSTL135_S	0.69	0.72	0.82	0.91	0.97	1.10	1.19	1.35	1.60	1.85	2.01	1.96	ns
DIFF_SSTL135_DCI_S	0.69	0.72	0.82	0.76	0.97	1.09	1.19	1.33	1.60	1.85	2.01	1.94	ns
DIFF_SSTL135_T_DCI_S	0.69	0.72	0.82	0.76	0.97	1.09	1.19	1.43	1.60	1.85	2.01	2.04	ns
DIFF_SSTL12_S	0.69	0.72	0.82	0.91	0.96	1.09	1.18	1.33	1.60	1.84	2.00	1.94	ns
DIFF_SSTL12_DCI_S	0.69	0.72	0.82	0.78	1.03	1.17	1.27	1.33	1.66	1.92	2.09	1.94	ns
DIFF_SSTL12_T_DCI_S	0.69	0.72	0.82	0.80	1.03	1.17	1.27	1.41	1.66	1.92	2.09	2.02	ns

**Table 20: 1.8V IOB High Performance (HP) Switching Characteristics (Cont'd)**

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units
	Speed Grade				Speed Grade				Speed Grade				
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V		
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	
SSTL18_I_F	0.68	0.72	0.82	0.86	0.94	1.06	1.15	1.32	1.58	1.82	1.97	1.93	ns
SSTL18_II_F	0.68	0.72	0.82	0.87	0.97	1.09	1.16	1.36	1.61	1.84	1.99	1.98	ns
SSTL18_I_DCI_F	0.68	0.72	0.82	0.76	0.89	1.02	1.10	1.30	1.53	1.77	1.92	1.91	ns
SSTL18_II_DCI_F	0.68	0.72	0.82	0.78	0.89	1.02	1.10	1.24	1.53	1.77	1.92	1.85	ns
SSTL18_II_T_DCI_F	0.68	0.72	0.82	0.78	0.89	1.02	1.10	1.27	1.53	1.77	1.92	1.88	ns
SSTL15_F	0.68	0.72	0.82	0.81	0.89	1.01	1.09	1.24	1.53	1.77	1.91	1.85	ns
SSTL15_DCI_F	0.68	0.72	0.82	0.78	0.89	1.01	1.09	1.27	1.53	1.77	1.91	1.88	ns
SSTL15_T_DCI_F	0.68	0.72	0.82	0.80	0.89	1.01	1.09	1.27	1.53	1.77	1.91	1.88	ns
SSTL135_F	0.69	0.72	0.82	0.89	0.88	1.00	1.08	1.27	1.52	1.76	1.90	1.88	ns
SSTL135_DCI_F	0.69	0.72	0.82	0.84	0.89	1.00	1.08	1.27	1.52	1.76	1.90	1.88	ns
SSTL135_T_DCI_F	0.69	0.72	0.82	0.84	0.89	1.00	1.08	1.27	1.52	1.76	1.90	1.88	ns
SSTL12_F	0.69	0.72	0.82	0.95	0.88	1.00	1.08	1.26	1.52	1.76	1.90	1.87	ns
SSTL12_DCI_F	0.69	0.72	0.82	0.91	0.91	1.03	1.11	1.24	1.54	1.79	1.93	1.85	ns
SSTL12_T_DCI_F	0.69	0.72	0.82	0.91	0.91	1.03	1.11	1.26	1.54	1.79	1.93	1.87	ns
DIFF_SSTL18_I_F	0.75	0.79	0.92	0.89	0.94	1.06	1.15	1.38	1.58	1.82	1.97	1.99	ns
DIFF_SSTL18_II_F	0.75	0.79	0.92	0.89	0.97	1.09	1.16	1.40	1.61	1.84	1.99	2.01	ns
DIFF_SSTL18_I_DCI_F	0.75	0.79	0.92	0.76	0.89	1.02	1.10	1.36	1.53	1.77	1.92	1.98	ns
DIFF_SSTL18_II_DCI_F	0.75	0.79	0.92	0.75	0.89	1.02	1.10	1.32	1.53	1.77	1.92	1.93	ns
DIFF_SSTL18_II_T_DCI_F	0.75	0.79	0.92	0.76	0.89	1.02	1.10	1.38	1.53	1.77	1.92	1.99	ns
DIFF_SSTL15_F	0.68	0.72	0.82	0.89	0.89	1.01	1.09	1.24	1.53	1.77	1.91	1.85	ns
DIFF_SSTL15_DCI_F	0.68	0.72	0.82	0.75	0.89	1.01	1.09	1.27	1.53	1.77	1.91	1.88	ns
DIFF_SSTL15_T_DCI_F	0.68	0.72	0.82	0.76	0.89	1.01	1.09	1.35	1.53	1.77	1.91	1.96	ns
DIFF_SSTL135_F	0.69	0.72	0.82	0.91	0.88	1.00	1.08	1.27	1.52	1.76	1.90	1.88	ns
DIFF_SSTL135_DCI_F	0.69	0.72	0.82	0.76	0.89	1.00	1.08	1.27	1.52	1.76	1.90	1.88	ns
DIFF_SSTL135_T_DCI_F	0.69	0.72	0.82	0.76	0.89	1.00	1.08	1.35	1.52	1.76	1.90	1.96	ns
DIFF_SSTL12_F	0.69	0.72	0.82	0.91	0.88	1.00	1.08	1.26	1.52	1.76	1.90	1.87	ns
DIFF_SSTL12_DCI_F	0.69	0.72	0.82	0.78	0.91	1.03	1.11	1.24	1.54	1.79	1.93	1.85	ns
DIFF_SSTL12_T_DCI_F	0.69	0.72	0.82	0.80	0.91	1.03	1.11	1.33	1.54	1.79	1.93	1.94	ns

**Notes:**

1. This I/O standard is only available in the 1.8V high-performance (HP) banks.

Table 21 specifies the values of  $T_{IOTPHZ}$  and  $T_{IOIBUFDISABLE}$ .  $T_{IOTPHZ}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is enabled (i.e., a high impedance state).  $T_{IOIBUFDISABLE}$  is described as the IOB delay from IBUFDISABLE to O output. In HP I/O banks, the internal DCI termination turn-off time is always faster than  $T_{IOTPHZ}$  when the DCITERMDISABLE pin is used. In HR I/O banks, the internal IN\_TERM termination turn-off time is always faster than  $T_{IOTPHZ}$  when the INTERMDISABLE pin is used.

**Table 21: IOB 3-state Output Switching Characteristics**

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
$T_{IOTPHZ}$	T input to pad high-impedance	0.76	0.86	0.99	0.62	ns
$T_{IOIBUFDISABLE\_HR}$	IBUF turn-on time from IBUFDISABLE to O output for HR I/O banks	1.72	1.89	2.14	2.17	ns
$T_{IOIBUFDISABLE\_HP}$	IBUF turn-on time from IBUFDISABLE to O output for HP I/O banks	1.31	1.46	1.76	1.86	ns

## Input/Output Logic Switching Characteristics

Table 22: ILOGIC Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
$T_{ICE1CK}/T_{ICKCE1}$	CE1 pin Setup/Hold with respect to CLK	0.42/0.00	0.48/0.00	0.67/0.00	0.56/-0.16	ns
$T_{ISRCK}/T_{ICKSR}$	SR pin Setup/Hold with respect to CLK	0.53/0.01	0.61/0.01	0.99/0.01	0.88/-0.30	ns
$T_{IDOCKE2}/T_{IOCKDE2}$	D pin Setup/Hold with respect to CLK without Delay (HP I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	0.01/0.41	ns
$T_{IDOCKDE2}/T_{IOCKDDE2}$	DDLY pin Setup/Hold with respect to CLK (using IDELAY) (HP I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	0.01/0.41	ns
$T_{IDOCKE3}/T_{IOCKDE3}$	D pin Setup/Hold with respect to CLK without Delay (HR I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	0.01/0.41	ns
$T_{IDOCKDE3}/T_{IOCKDDE3}$	DDLY pin Setup/Hold with respect to CLK (using IDELAY) (HR I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	0.01/0.41	ns
<b>Combinatorial</b>						
$T_{IDIE2}$	D pin to O pin propagation delay, no Delay (HP I/O banks only)	0.09	0.10	0.12	0.14	ns
$T_{IDIDE2}$	DDLY pin to O pin propagation delay (using IDELAY) (HP I/O banks only)	0.10	0.11	0.13	0.15	ns
$T_{IDIE3}$	D pin to O pin propagation delay, no Delay (HR I/O banks only)	0.09	0.10	0.12	0.14	ns
$T_{IDIDE3}$	DDLY pin to O pin propagation delay (using IDELAY) (HR I/O banks only)	0.10	0.11	0.13	0.15	ns
<b>Sequential Delays</b>						
$T_{IDLOE2}$	D pin to Q1 pin using flip-flop as a latch without Delay (HP I/O banks only)	0.36	0.39	0.45	0.54	ns
$T_{IDLODE2}$	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HP I/O banks only)	0.36	0.39	0.45	0.55	ns
$T_{IDLOE3}$	D pin to Q1 pin using flip-flop as a latch without Delay (HR I/O banks only)	0.36	0.39	0.45	0.54	ns
$T_{IDLODE3}$	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HR I/O banks only)	0.36	0.39	0.45	0.55	ns
$T_{ICKQ}$	CLK to Q outputs	0.47	0.50	0.58	0.71	ns
$T_{RQ\_ILOGICE2}$	SR pin to OQ/TQ out (HP I/O banks only)	0.84	0.94	1.16	1.32	ns
$T_{GSRQ\_ILOGICE2}$	Global Set/Reset to Q outputs (HP I/O banks only)	7.60	7.60	10.51	11.39	ns
$T_{RQ\_ILOGICE3}$	SR pin to OQ/TQ out (HR I/O banks only)	0.84	0.94	1.16	1.32	ns
$T_{GSRQ\_ILOGICE3}$	Global Set/Reset to Q outputs (HR I/O banks only)	7.60	7.60	10.51	11.39	ns
<b>Set/Reset</b>						
$T_{RPW\_ILOGICE2}$	Minimum Pulse Width, SR inputs (HP I/O banks only)	0.54	0.63	0.63	0.68	ns, Min
$T_{RPW\_ILOGICE3}$	Minimum Pulse Width, SR inputs (HR I/O banks only)	0.54	0.63	0.63	0.68	ns, Min

Table 23: OLOGIC Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
$T_{ODCK}/T_{OCKD}$	D1/D2 pins Setup/Hold with respect to CLK	0.45/-0.13	0.50/-0.13	0.58/-0.13	0.79/-0.18	ns
$T_{OOCECK}/T_{OCKOCE}$	OCE pin Setup/Hold with respect to CLK	0.28/0.03	0.29/0.03	0.45/0.03	0.35/-0.10	ns
$T_{OSRCK}/T_{OCKSR}$	SR pin Setup/Hold with respect to CLK	0.32/0.18	0.38/0.18	0.70/0.18	0.62/-0.04	ns
$T_{OTCK}/T_{OCKT}$	T1/T2 pins Setup/Hold with respect to CLK	0.49/-0.16	0.56/-0.16	0.68/-0.16	0.67/-0.18	ns
$T_{OTCECK}/T_{OCKTCE}$	TCE pin Setup/Hold with respect to CLK	0.28/0.01	0.30/0.01	0.45/0.01	0.31/-0.10	ns
<b>Combinatorial</b>						
$T_{ODQ}$	D1 to OQ out or T1 to TQ out	0.73	0.81	0.97	1.18	ns
<b>Sequential Delays</b>						
$T_{OCKQ}$	CLK to OQ/TQ out	0.41	0.43	0.49	0.63	ns
$T_{RQ\_OLOGICE2}$	SR pin to OQ/TQ out (HP I/O banks only)	0.63	0.70	0.83	1.12	ns
$T_{GSRQ\_OLOGICE2}$	Global Set/Reset to Q outputs (HP I/O banks only)	7.60	7.60	10.51	11.39	ns
$T_{RQ\_OLOGICE3}$	SR pin to OQ/TQ out (HR I/O banks only)	0.63	0.70	0.83	1.12	ns
$T_{GSRQ\_OLOGICE3}$	Global Set/Reset to Q outputs (HR I/O banks only)	7.60	7.60	10.51	11.39	ns
<b>Set/Reset</b>						
$T_{RPW\_OLOGICE2}$	Minimum Pulse Width, SR inputs (HP I/O banks only)	0.54	0.54	0.63	0.68	ns, Min
$T_{RPW\_OLOGICE3}$	Minimum Pulse Width, SR inputs (HR I/O banks only)	0.54	0.54	0.63	0.68	ns, Min



## Input Serializer/Deserializer Switching Characteristics

Table 24: ISERDES Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold for Control Lines</b>						
$T_{ISCK\_BITSLIP}/T_{ISCK\_BITSLIP}$	BITSLIP pin Setup/Hold with respect to CLKDIV	0.01/0.12	0.02/0.13	0.02/0.15	0.02/0.21	ns
$T_{ISCK\_CE}/T_{ISCK\_CE}^{(2)}$	CE pin Setup/Hold with respect to CLK (for CE1)	0.39/-0.02	0.44/-0.02	0.63/-0.02	0.51/-0.22	ns
$T_{ISCK\_CE2}/T_{ISCK\_CE2}^{(2)}$	CE pin Setup/Hold with respect to CLKDIV (for CE2)	-0.12/0.29	-0.12/0.31	-0.12/0.35	-0.17/0.40	ns
<b>Setup/Hold for Data Lines</b>						
$T_{ISDCK\_D}/T_{ISCKD\_D}$	D pin Setup/Hold with respect to CLK	-0.02/0.11	-0.02/0.12	-0.02/0.15	-0.04/0.19	ns
$T_{ISDCK\_DDL}/T_{ISCKD\_DDL}$	DDL pin Setup/Hold with respect to CLK (using IDELAY) <sup>(1)</sup>	-0.02/0.11	-0.02/0.12	-0.02/0.15	-0.03/0.19	ns
$T_{ISDCK\_D\_DDR}/T_{ISCKD\_D\_DDR}$	D pin Setup/Hold with respect to CLK at DDR mode	-0.02/0.11	-0.02/0.12	-0.02/0.15	-0.04/0.19	ns
$T_{ISDCK\_DDL\_DDR}/T_{ISCKD\_DDL\_DDR}$	D pin Setup/Hold with respect to CLK at DDR mode (using IDELAY) <sup>(1)</sup>	0.11/0.11	0.12/0.12	0.15/0.15	0.19/0.19	ns
<b>Sequential Delays</b>						
$T_{ISCKO\_Q}$	CLKDIV to out at Q pin	0.46	0.47	0.58	0.67	ns
<b>Propagation Delays</b>						
$T_{ISDO\_DO}$	D input to DO output pin	0.09	0.10	0.12	0.14	ns

**Notes:**

1. Recorded at 0 tap value.
2.  $T_{ISCK\_CE2}$  and  $T_{ISCK\_CE2}$  are reported as  $T_{ISCK\_CE}/T_{ISCK\_CE}$  in TRACE report.

## Output Serializer/Deserializer Switching Characteristics

Table 25: OSERDES Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold</b>						
$T_{OSDCK\_D}/T_{OSCKD\_D}$	D input Setup/Hold with respect to CLKDIV	0.37/0.02	0.40/0.02	0.55/0.02	0.44/-0.24	ns
$T_{OSDCK\_T}/T_{OSCKD\_T}^{(1)}$	T input Setup/Hold with respect to CLK	0.49/-0.15	0.56/-0.15	0.68/-0.15	0.67/-0.25	ns
$T_{OSDCK\_T2}/T_{OSCKD\_T2}^{(1)}$	T input Setup/Hold with respect to CLKDIV	0.27/-0.15	0.30/-0.15	0.34/-0.15	0.46/-0.25	ns
$T_{OSCK\_OCE}/T_{OSCKC\_OCE}$	OCE input Setup/Hold with respect to CLK	0.28/0.03	0.29/0.03	0.45/0.03	0.35/-0.15	ns
$T_{OSCK\_S}$	SR (Reset) input Setup with respect to CLKDIV	0.41	0.46	0.75	0.70	ns
$T_{OSCK\_TCE}/T_{OSCKC\_TCE}$	TCE input Setup/Hold with respect to CLK	0.28/0.01	0.30/0.01	0.45/0.01	0.31/-0.15	ns
<b>Sequential Delays</b>						
$T_{OSCKO\_OQ}$	Clock to out from CLK to OQ	0.35	0.37	0.42	0.54	ns
$T_{OSCKO\_TQ}$	Clock to out from CLK to TQ	0.41	0.43	0.49	0.63	ns
<b>Combinatorial</b>						
$T_{OSDO\_TTQ}$	T input to TQ Out	0.73	0.81	0.97	1.18	ns

**Notes:**

- $T_{OSDCK\_T2}$  and  $T_{OSCKD\_T2}$  are reported as  $T_{OSDCK\_T}/T_{OSCKD\_T}$  in TRACE report.

## Input/Output Delay Switching Characteristics

Table 26: Input/Output Delay Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>IDELAYCTRL</b>						
T <sub>DLYCCO_RDY</sub>	Reset to Ready for IDELAYCTRL	3.22	3.22	3.22	3.22	µs
F <sub>IDELAYCTRL_REF</sub>	Attribute REFCLK frequency = 200.00 <sup>(1)</sup>	200.00	200.00	200.00	200.00	MHz
	Attribute REFCLK frequency = 300.00 <sup>(1)</sup>	300.00	300.00	N/A	N/A	MHz
IDELAYCTRL_REF_PRECISION	REFCLK precision	±10	±10	±10	±10	MHz
T <sub>IDELAYCTRL_RPW</sub>	Minimum Reset pulse width	52.00	52.00	52.00	52.00	ns
<b>IDELAY/ODELAY</b>						
T <sub>IDELAYRESOLUTION</sub>	IDELAY/ODELAY chain delay resolution	1/(32 x 2 x F <sub>REF</sub> )				ps
T <sub>IDELAYPAT_JIT</sub> and T <sub>ODELAYPAT_JIT</sub>	Pattern dependent period jitter in delay chain for clock pattern. <sup>(2)</sup>	0	0	0	0	ps per tap
	Pattern dependent period jitter in delay chain for random data pattern (PRBS 23) <sup>(3)</sup>	±5	±5	±5	±5	ps per tap
	Pattern dependent period jitter in delay chain for random data pattern (PRBS 23) <sup>(4)</sup>	±9	±9	±9	±9	ps per tap
T <sub>IDELAY_CLK_MAX</sub> / T <sub>ODELAY_CLK_MAX</sub>	Maximum frequency of CLK input to IDELAY/ODELAY	800.00	800.00	710.00	710.00	MHz
T <sub>IDCCK_CE</sub> / T <sub>IDCKC_CE</sub>	CE pin Setup/Hold with respect to C for IDELAY	0.11/0.10	0.14/0.12	0.18/0.14	0.14/0.16	ns
T <sub>ODCCK_CE</sub> / T <sub>ODCKC_CE</sub>	CE pin Setup/Hold with respect to C for ODELAY	0.14/0.03	0.16/0.04	0.19/0.05	0.28/0.06	ns
T <sub>IDCCK_INC</sub> / T <sub>IDCKC_INC</sub>	INC pin Setup/Hold with respect to C for IDELAY	0.10/0.14	0.12/0.16	0.14/0.20	0.10/0.23	ns
T <sub>ODCCK_INC</sub> / T <sub>ODCKC_INC</sub>	INC pin Setup/Hold with respect to C for ODELAY	0.10/0.07	0.12/0.08	0.13/0.09	0.19/0.16	ns
T <sub>IDCCK_RST</sub> / T <sub>IDCKC_RST</sub>	RST pin Setup/Hold with respect to C for IDELAY	0.13/0.08	0.14/0.10	0.16/0.12	0.22/0.19	ns
T <sub>ODCCK_RST</sub> / T <sub>ODCKC_RST</sub>	RST pin Setup/Hold with respect to C for ODELAY	0.16/0.04	0.19/0.06	0.24/0.08	0.32/0.11	ns
T <sub>IDDO_IDATAIN</sub>	Propagation delay through IDELAY	Note 5	Note 5	Note 5	Note 5	ps
T <sub>ODDO_ODATAIN</sub>	Propagation delay through ODELAY	Note 5	Note 5	Note 5	Note 5	ps

**Notes:**

1. Average Tap Delay at 200 MHz = 78 ps, at 300 MHz = 52 ps.
2. When HIGH\_PERFORMANCE mode is set to TRUE or FALSE.
3. When HIGH\_PERFORMANCE mode is set to TRUE.
4. When HIGH\_PERFORMANCE mode is set to FALSE.
5. Delay depends on IDELAY/ODELAY tap setting. See TRACE report for actual values.

Table 27: IO\_FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>IO_FIFO Clock to Out Delays</b>						
$T_{OFFCKO\_DO}$	RDCLK to Q outputs	0.51	0.56	0.63	0.81	ns
$T_{CKO\_FLAGS}$	Clock to IO_FIFO Flags	0.59	0.62	0.81	0.77	ns
<b>Setup/Hold</b>						
$T_{CCK\_D}/T_{CKC\_D}$	D inputs to WRCLK	0.43/-0.01	0.47/-0.01	0.53/-0.01	0.76/-0.05	ns
$T_{IFFCK\_WREN}/T_{IFFCKC\_WREN}$	WREN to WRCLK	0.39/-0.01	0.43/-0.01	0.50/-0.01	0.70/-0.05	ns
$T_{OFFCK\_RDEN}/T_{OFFCKC\_RDEN}$	RDEN to RDCLK	0.49/0.01	0.53/0.02	0.61/0.02	0.79/-0.02	ns
<b>Minimum Pulse Width</b>						
$T_{PWH\_IO\_FIFO}$	RESET, RDCLK, WRCLK	0.81	0.92	1.08	1.29	ns
$T_{PWL\_IO\_FIFO}$	RESET, RDCLK, WRCLK	0.81	0.92	1.08	1.29	ns
<b>Maximum Frequency</b>						
$F_{MAX}$	RDCLK and WRCLK	533.05	470.37	400.00	333.33	MHz

## CLB Switching Characteristics

Table 28: CLB Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Combinatorial Delays</b>						
$T_{ILO}$	An – Dn LUT address to A	0.05	0.05	0.06	0.07	ns, Max
$T_{ILO\_2}$	An – Dn LUT address to AMUX/CMUX	0.15	0.16	0.19	0.22	ns, Max
$T_{ILO\_3}$	An – Dn LUT address to BMUX_A	0.24	0.25	0.30	0.37	ns, Max
$T_{ITO}$	An – Dn inputs to A – D Q outputs	0.58	0.61	0.74	0.91	ns, Max
$T_{AXA}$	AX inputs to AMUX output	0.38	0.40	0.49	0.62	ns, Max
$T_{AXB}$	AX inputs to BMUX output	0.40	0.42	0.52	0.66	ns, Max
$T_{AXC}$	AX inputs to CMUX output	0.39	0.41	0.50	0.62	ns, Max
$T_{AXD}$	AX inputs to DMUX output	0.43	0.44	0.52	0.67	ns, Max
$T_{BxB}$	BX inputs to BMUX output	0.31	0.33	0.40	0.51	ns, Max
$T_{BxD}$	BX inputs to DMUX output	0.38	0.39	0.47	0.62	ns, Max
$T_{CxC}$	CX inputs to CMUX output	0.27	0.28	0.34	0.43	ns, Max
$T_{CxD}$	CX inputs to DMUX output	0.33	0.34	0.41	0.54	ns, Max
$T_{DxD}$	DX inputs to DMUX output	0.32	0.33	0.40	0.52	ns, Max
<b>Sequential Delays</b>						
$T_{CKO}$	Clock to AQ – DQ outputs	0.26	0.27	0.32	0.40	ns, Max
$T_{SHCKO}$	Clock to AMUX – DMUX outputs	0.32	0.32	0.39	0.46	ns, Max
<b>Setup and Hold Times of CLB Flip-Flops Before/After Clock CLK</b>						
$T_{AS}/T_{AH}$	$A_N – D_N$ input to CLK on A – D Flip Flops	0.01/0.12	0.02/0.13	0.03/0.18	0.02/0.18	ns, Min
$T_{DICK}/T_{CKDI}$	$A_X – D_X$ input to CLK on A – D Flip Flops	0.04/0.14	0.04/0.14	0.05/0.20	0.05/0.21	ns, Min
	$A_X – D_X$ input through MUXs and/or carry logic to CLK on A – D Flip Flops	0.36/0.10	0.37/0.11	0.46/0.16	0.56/0.15	ns, Min
$T_{CECK\_CLB}/T_{CKCE\_CLB}$	CE input to CLK on A – D Flip Flops	0.19/0.05	0.20/0.05	0.25/0.05	0.24/0.04	ns, Min
$T_{SRCK}/T_{CKSR}$	SR input to CLK on A – D Flip Flops	0.30/0.05	0.31/0.07	0.37/0.09	0.48/0.05	ns, Min
<b>Set/Reset</b>						
$T_{SRMIN}$	SR input minimum pulse width	0.52	0.78	1.04	0.95	ns, Min
$T_{RQ}$	Delay from SR input to AQ – DQ flip-flops	0.38	0.38	0.46	0.59	ns, Max
$T_{CEO}$	Delay from CE input to AQ – DQ flip-flops	0.34	0.35	0.43	0.54	ns, Max
$F_{TOG}$	Toggle frequency (for export control)	1818	1818	1818	1286	MHz

**CLB Distributed RAM Switching Characteristics (SLICEM Only)**

Table 29: CLB Distributed RAM Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Sequential Delays</b>						
T <sub>SHCKO</sub>	Clock to A – B outputs	0.68	0.70	0.85	1.08	ns, Max
T <sub>SHCKO_1</sub>	Clock to AMUX – BMUX outputs	0.91	0.95	1.15	1.44	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>DS_LRAM</sub> /T <sub>DH_LRAM</sub>	A – D inputs to CLK	0.45/0.23	0.45/0.24	0.54/0.27	0.69/0.33	ns, Min
T <sub>AS_LRAM</sub> /T <sub>AH_LRAM</sub>	Address An inputs to clock	0.13/0.50	0.14/0.50	0.17/0.58	0.21/0.63	ns, Min
	Address An inputs through MUXs and/or carry logic to clock	0.40/0.16	0.42/0.17	0.52/0.23	0.63/0.23	ns, Min
T <sub>WS_LRAM</sub> /T <sub>WH_LRAM</sub>	WE input to clock	0.29/0.09	0.30/0.09	0.36/0.09	0.46/0.10	ns, Min
T <sub>CECK_LRAM</sub> / T <sub>CKCE_LRAM</sub>	CE input to CLK	0.29/0.09	0.30/0.09	0.37/0.09	0.47/0.10	ns, Min
<b>Clock CLK</b>						
T <sub>MPW</sub>	Minimum pulse width	0.68	0.77	0.91	1.11	ns, Min
T <sub>MCP</sub>	Minimum clock period	1.35	1.54	1.82	2.22	ns, Min

**Notes:**

1. A Zero “0” Hold Time listing indicates no hold time or a negative hold time.
2. T<sub>SHCKO</sub> also represents the CLK to XMUX output. Refer to TRACE report for the CLK to XMUX path.

**CLB Shift Register Switching Characteristics (SLICEM Only)**

Table 30: CLB Shift Register Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Sequential Delays</b>						
T <sub>REG</sub>	Clock to A – D outputs	0.96	0.98	1.20	1.35	ns, Max
T <sub>REG_MUX</sub>	Clock to AMUX – DMUX output	1.19	1.23	1.50	1.72	ns, Max
T <sub>REG_M31</sub>	Clock to DMUX output via M31 output	0.89	0.91	1.10	1.25	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>WS_SHFREG</sub> / T <sub>WH_SHFREG</sub>	WE input	0.26/0.09	0.27/0.09	0.33/0.09	0.41/0.10	ns, Min
T <sub>CECK_SHFREG</sub> / T <sub>CKCE_SHFREG</sub>	CE input to CLK	0.27/0.09	0.28/0.09	0.33/0.09	0.42/0.10	ns, Min
T <sub>DS_SHFREG</sub> / T <sub>DH_SHFREG</sub>	A – D inputs to CLK	0.28/0.26	0.28/0.26	0.33/0.30	0.41/0.36	ns, Min
<b>Clock CLK</b>						
T <sub>MPW_SHFREG</sub>	Minimum pulse width	0.55	0.65	0.78	0.91	ns, Min

**Notes:**

1. A Zero “0” Hold Time listing indicates no hold time or a negative hold time.

## Block RAM and FIFO Switching Characteristics

Table 31: Block RAM and FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Block RAM and FIFO Clock-to-Out Delays</b>						
T <sub>RCKO_DO</sub> and T <sub>RCKO_DO_REG</sub> <sup>(1)</sup>	Clock CLK to DOUT output (without output register) <sup>(2)(3)</sup>	1.57	1.80	2.08	2.44	ns, Max
	Clock CLK to DOUT output (with output register) <sup>(4)(5)</sup>	0.54	0.63	0.75	0.86	ns, Max
T <sub>RCKO_DO_ECC</sub> and T <sub>RCKO_DO_ECC_REG</sub>	Clock CLK to DOUT output with ECC (without output register) <sup>(2)(3)</sup>	2.35	2.58	3.26	4.49	ns, Max
	Clock CLK to DOUT output with ECC (with output register) <sup>(4)(5)</sup>	0.62	0.69	0.80	0.94	ns, Max
T <sub>RCKO_DO_CASCOUT</sub> and T <sub>RCKO_DO_CASCOUT_REG</sub>	Clock CLK to DOUT output with Cascade (without output register) <sup>(2)</sup>	2.21	2.45	2.80	3.19	ns, Max
	Clock CLK to DOUT output with Cascade (with output register) <sup>(4)</sup>	0.98	1.08	1.24	1.32	ns, Max
T <sub>RCKO_FLAGS</sub>	Clock CLK to FIFO flags outputs <sup>(6)</sup>	0.65	0.74	0.89	0.97	ns, Max
T <sub>RCKO_POINTERS</sub>	Clock CLK to FIFO pointers outputs <sup>(7)</sup>	0.79	0.87	0.98	1.10	ns, Max
T <sub>RCKO_PARITY_ECC</sub>	Clock CLK to ECCPARITY in ECC encode only mode	0.66	0.72	0.80	0.93	ns, Max
T <sub>RCKO_SDBIT_ECC</sub> and T <sub>RCKO_SDBIT_ECC_REG</sub>	Clock CLK to BITERR (without output register)	2.17	2.38	3.01	4.15	ns, Max
	Clock CLK to BITERR (with output register)	0.57	0.65	0.76	0.89	ns, Max
T <sub>RCKO_RDADDR_ECC</sub> and T <sub>RCKO_RDADDR_ECC_REG</sub>	Clock CLK to RDADDR output with ECC (without output register)	0.64	0.74	0.90	0.98	ns, Max
	Clock CLK to RDADDR output with ECC (with output register)	0.71	0.79	0.92	1.10	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>RCKC_ADDRA</sub> /T <sub>RCKC_ADDRA</sub>	ADDR inputs <sup>(8)</sup>	0.38/0.27	0.42/0.28	0.48/0.31	0.65/0.38	ns, Min
T <sub>RDCK_DI_WF_NC</sub> / T <sub>RCKD_DI_WF_NC</sub>	Data input setup/hold time when block RAM is configured in WRITE_FIRST or NO_CHANGE mode <sup>(9)</sup>	0.49/0.51	0.55/0.53	0.63/0.57	0.78/0.64	ns, Min
T <sub>RDCK_DI_RF</sub> /T <sub>RCKD_DI_RF</sub>	Data input setup/hold time when block RAM is configured in READ_FIRST mode <sup>(9)</sup>	0.17/0.25	0.19/0.29	0.21/0.35	0.25/0.32	ns, Min
T <sub>RDCK_DI_ECC</sub> / T <sub>RCKD_DI_ECC</sub>	DIN inputs with block RAM ECC in standard mode <sup>(9)</sup>	0.42/0.37	0.47/0.39	0.53/0.43	0.66/0.46	ns, Min
T <sub>RDCK_DI_ECCW</sub> / T <sub>RCKD_DI_ECCW</sub>	DIN inputs with block RAM ECC encode only <sup>(9)</sup>	0.79/0.37	0.87/0.39	0.99/0.43	1.17/0.41	ns, Min
T <sub>RDCK_DI_ECC_FIFO</sub> / T <sub>RCKD_DI_ECC_FIFO</sub>	DIN inputs with FIFO ECC in standard mode <sup>(9)</sup>	0.89/0.47	0.98/0.50	1.12/0.54	1.32/0.65	ns, Min
T <sub>RCKC_INJECTBITERR</sub> / T <sub>RCKC_INJECTBITERR</sub>	Inject single/double bit error in ECC mode	0.49/0.30	0.55/0.31	0.63/0.34	0.78/0.41	ns, Min
T <sub>RCKC_EN</sub> /T <sub>RCKC_EN</sub>	Block RAM Enable (EN) input	0.30/0.17	0.33/0.18	0.38/0.20	0.48/0.22	ns, Min
T <sub>RCKC_REGCE</sub> /T <sub>RCKC_REGCE</sub>	CE input of output register	0.21/0.13	0.25/0.13	0.31/0.14	0.34/0.16	ns, Min
T <sub>RCKC_RSTREG</sub> /T <sub>RCKC_RSTREG</sub>	Synchronous RSTREG input	0.25/0.06	0.27/0.06	0.29/0.06	0.35/0.06	ns, Min

Table 31: Block RAM and FIFO Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
$T_{RCKK\_RSTRAM}/T_{RCKC\_RSTRAM}$	Synchronous RSTRAM input	0.27/0.35	0.29/0.37	0.31/0.39	0.34/0.40	ns, Min
$T_{RCKK\_WEA}/T_{RCKC\_WEA}$	Write Enable (WE) input (Block RAM only)	0.38/0.15	0.41/0.16	0.46/0.17	0.54/0.19	ns, Min
$T_{RCKK\_WREN}/T_{RCKC\_WREN}$	WREN FIFO inputs	0.39/0.25	0.39/0.30	0.40/0.37	0.65/0.37	ns, Min
$T_{RCKK\_RDEN}/T_{RCKC\_RDEN}$	RDEN FIFO inputs	0.36/0.26	0.36/0.30	0.37/0.37	0.60/0.38	ns, Min
<b>Reset Delays</b>						
$T_{RCO\_FLAGS}$	Reset RST to FIFO flags/pointers <sup>(10)</sup>	0.76	0.83	0.93	1.06	ns, Max
$T_{RREC\_RST}/T_{RREM\_RST}$	FIFO reset recovery and removal timing <sup>(11)</sup>	1.59/-0.68	1.76/-0.68	2.01/-0.68	2.07/-0.60	ns, Max
<b>Maximum Frequency</b>						
$F_{MAX\_BRAM\_WF\_NC}$	Block RAM (Write first and No change modes) When not in SDP RF mode	601.32	543.77	458.09	372.44	MHz
$F_{MAX\_BRAM\_RF\_PERFORMANCE}$	Block RAM (Read first, Performance mode) When in SDP RF mode but no address overlap between port A and port B	601.32	543.77	458.09	372.44	MHz
$F_{MAX\_BRAM\_RF\_DELAYED\_WRITE}$	Block RAM (Read first, Delayed_write mode) When in SDP RF mode and there is possibility of overlap between port A and port B addresses	528.26	477.33	400.80	317.36	MHz
$F_{MAX\_CAS\_WF\_NC}$	Block RAM Cascade (Write first, No change mode) When cascade but not in RF mode	551.27	493.83	408.00	322.48	MHz
$F_{MAX\_CAS\_RF\_PERFORMANCE}$	Block RAM Cascade (Read first, Performance mode) When in cascade with RF mode and no possibility of address overlap/one port is disabled	551.27	493.83	408.00	322.48	MHz
$F_{MAX\_CAS\_RF\_DELAYED\_WRITE}$	When in cascade RF mode and there is a possibility of address overlap between port A and port B	478.27	427.35	350.88	267.38	MHz
$F_{MAX\_FIFO}$	FIFO in all modes without ECC	601.32	543.77	458.09	372.44	MHz
$F_{MAX\_ECC}$	Block RAM and FIFO in ECC configuration	484.26	430.85	351.12	254.13	MHz

**Notes:**

- TRACE will report all of these parameters as  $T_{RCKO\_DO}$ .
- $T_{RCKO\_DOR}$  includes  $T_{RCKO\_DOW}$ ,  $T_{RCKO\_DOPR}$ , and  $T_{RCKO\_DOPW}$  as well as the B port equivalent timing parameters.
- These parameters also apply to synchronous FIFO with  $DO\_REG = 0$ .
- $T_{RCKO\_DO}$  includes  $T_{RCKO\_DOP}$  as well as the B port equivalent timing parameters.
- These parameters also apply to multirate (asynchronous) and synchronous FIFO with  $DO\_REG = 1$ .
- $T_{RCKO\_FLAGS}$  includes the following parameters:  $T_{RCKO\_AEMPTY}$ ,  $T_{RCKO\_AFULL}$ ,  $T_{RCKO\_EMPTY}$ ,  $T_{RCKO\_FULL}$ ,  $T_{RCKO\_RDERR}$ ,  $T_{RCKO\_WRERR}$ .
- $T_{RCKO\_POINTERS}$  includes both  $T_{RCKO\_RDCOUNT}$  and  $T_{RCKO\_WRCOUNT}$ .
- The ADDR setup and hold must be met when EN is asserted (even when WE is deasserted). Otherwise, block RAM data corruption is possible.
- These parameters include both A and B inputs as well as the parity inputs of A and B.
- $T_{RCO\_FLAGS}$  includes the following flags: AEMPTY, AFULL, EMPTY, FULL, RDERR, WRERR, RDCOUNT, and WRCOUNT.
- RDEN and WREN must be held Low prior to and during reset. The FIFO reset must be asserted for at least five positive clock edges of the slowest clock (WRCLK or RDCLK).



## DSP48E1 Switching Characteristics

Table 32: DSP48E1 Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Setup and Hold Times of Data/Control Pins to the Input Register Clock</b>						
$T_{\text{DSPDCK\_A\_AREG}}/T_{\text{DSPCKD\_A\_AREG}}$	A input to A register CLK	0.24/ 0.12	0.27/ 0.14	0.31/ 0.16	0.38/ 0.12	ns
$T_{\text{DSPDCK\_B\_BREG}}/T_{\text{DSPCKD\_B\_BREG}}$	B input to B register CLK	0.28/ 0.13	0.32/ 0.14	0.39/ 0.15	0.51/ 0.16	ns
$T_{\text{DSPDCK\_C\_CREG}}/T_{\text{DSPCKD\_C\_CREG}}$	C input to C register CLK	0.15/ 0.15	0.17/ 0.17	0.20/ 0.20	0.31/ 0.21	ns
$T_{\text{DSPDCK\_D\_DREG}}/T_{\text{DSPCKD\_D\_DREG}}$	D input to D register CLK	0.21/ 0.19	0.27/ 0.22	0.35/ 0.26	0.46/ 0.20	ns
$T_{\text{DSPDCK\_ACIN\_AREG}}/T_{\text{DSPCKD\_ACIN\_AREG}}$	ACIN input to A register CLK	0.21/ 0.12	0.24/ 0.14	0.27/ 0.16	0.31/ 0.12	ns
$T_{\text{DSPDCK\_BCIN\_BREG}}/T_{\text{DSPCKD\_BCIN\_BREG}}$	BCIN input to B register CLK	0.22/ 0.13	0.25/ 0.14	0.30/ 0.15	0.34/ 0.16	ns
<b>Setup and Hold Times of Data Pins to the Pipeline Register Clock</b>						
$T_{\text{DSPDCK\_}\{A, B\}\_MREG\_MULT}/T_{\text{DSPCKD\_B\_MREG\_MULT}}$	{A, B,} input to M register CLK using multiplier	2.04/ -0.01	2.34/ -0.01	2.79/ -0.01	3.66/ -0.06	ns
$T_{\text{DSPDCK\_}\{A, B\}\_ADREG}/T_{\text{DSPCKD\_D\_ADREG}}$	{A, D} input to AD register CLK	1.09/ -0.02	1.25/ -0.02	1.49/ -0.02	1.94/ -0.23	ns
<b>Setup and Hold Times of Data/Control Pins to the Output Register Clock</b>						
$T_{\text{DSPDCK\_}\{A, B\}\_PREG\_MULT}/T_{\text{DSPCKD\_}\{A, B\}\_PREG\_MULT}$	{A, B,} input to P register CLK using multiplier	3.41/ -0.24	3.90/ -0.24	4.64/ -0.24	5.89/ -0.41	ns
$T_{\text{DSPDCK\_D\_PREG\_MULT}}/T_{\text{DSPCKD\_D\_PREG\_MULT}}$	D input to P register CLK using multiplier	3.33/ -0.62	3.81/ -0.62	4.53/ -0.62	5.70/ -1.42	ns
$T_{\text{DSPDCK\_}\{A, B\}\_PREG}/T_{\text{DSPCKD\_}\{A, B\}\_PREG}$	A or B input to P register CLK not using multiplier	1.47/ -0.24	1.68/ -0.24	2.00/ -0.24	2.37/ -0.41	ns
$T_{\text{DSPDCK\_C\_PREG}}/T_{\text{DSPCKD\_C\_PREG}}$	C input to P register CLK not using multiplier	1.30/ -0.22	1.49/ -0.22	1.78/ -0.22	2.11/ -0.36	ns
$T_{\text{DSPDCK\_PCIN\_PREG}}/T_{\text{DSPCKD\_PCIN\_PREG}}$	PCIN input to P register CLK	1.12/ -0.13	1.28/ -0.13	1.52/ -0.13	1.81/ -0.21	ns
<b>Setup and Hold Times of the CE Pins</b>						
$T_{\text{DSPDCK\_}\{CEA;CEB\}\_AREG;BREG}/T_{\text{DSPCKD\_}\{CEA;CEB\}\_AREG;BREG}$	{CEA; CEB} input to {A; B} register CLK	0.30/ 0.05	0.36/ 0.06	0.44/ 0.09	0.55/ 0.09	ns
$T_{\text{DSPDCK\_CEC\_CREG}}/T_{\text{DSPCKD\_CEC\_CREG}}$	CEC input to C register CLK	0.24/ 0.08	0.29/ 0.09	0.36/ 0.11	0.43/ 0.11	ns
$T_{\text{DSPDCK\_CED\_DREG}}/T_{\text{DSPCKD\_CED\_DREG}}$	CED input to D register CLK	0.31/ -0.02	0.36/ -0.02	0.44/ -0.02	0.58/ 0.12	ns
$T_{\text{DSPDCK\_CEM\_MREG}}/T_{\text{DSPCKD\_CEM\_MREG}}$	CEM input to M register CLK	0.26/ 0.15	0.29/ 0.17	0.33/ 0.20	0.39/ 0.25	ns
$T_{\text{DSPDCK\_CEP\_PREG}}/T_{\text{DSPCKD\_CEP\_PREG}}$	CEP input to P register CLK	0.31/ 0.01	0.36/ 0.01	0.45/ 0.01	0.54/ 0.00	ns

**Table 32: DSP48E1 Switching Characteristics (Cont'd)**

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Setup and Hold Times of the RST Pins</b>						
$T_{\text{DSPDCK}}\{\text{RSTA}; \text{RSTB}\}_{\text{AREG}; \text{BREG}} / T_{\text{DSPCKD}}\{\text{RSTA}; \text{RSTB}\}_{\text{AREG}; \text{BREG}}$	{RSTA, RSTB} input to {A, B} register CLK	0.34/ 0.10	0.39/ 0.11	0.47/ 0.13	0.53/ 0.34	ns
$T_{\text{DSPDCK\_RSTC\_CREG}} / T_{\text{DSPCKD\_RSTC\_CREG}}$	RSTC input to C register CLK	0.06/ 0.22	0.07/ 0.24	0.08/ 0.26	0.08/ 0.31	ns
$T_{\text{DSPDCK\_RSTD\_DREG}} / T_{\text{DSPCKD\_RSTD\_DREG}}$	RSTD input to D register CLK	0.37/ 0.06	0.42/ 0.06	0.50/ 0.07	0.57/ 0.07	ns
$T_{\text{DSPDCK\_RSTM\_MREG}} / T_{\text{DSPCKD\_RSTM\_MREG}}$	RSTM input to M register CLK	0.18/ 0.18	0.20/ 0.21	0.23/ 0.24	0.24/ 0.29	ns
$T_{\text{DSPDCK\_RSTP\_PREG}} / T_{\text{DSPCKD\_RSTP\_PREG}}$	RSTP input to P register CLK	0.24/ 0.01	0.26/ 0.01	0.30/ 0.01	0.37/ 0.00	ns
<b>Combinatorial Delays from Input Pins to Output Pins</b>						
$T_{\text{DSPDO\_A\_CARRYOUT\_MULT}}$	A input to CARRYOUT output using multiplier	3.21	3.69	4.39	5.60	ns
$T_{\text{DSPDO\_D\_P\_MULT}}$	D input to P output using multiplier	3.15	3.61	4.30	5.44	ns
$T_{\text{DSPDO\_A\_P}}$	A input to P output not using multiplier	1.30	1.48	1.76	2.10	ns
$T_{\text{DSPDO\_C\_P}}$	C input to P output	1.13	1.30	1.55	1.84	ns
<b>Combinatorial Delays from Input Pins to Cascading Output Pins</b>						
$T_{\text{DSPDO}}\{\text{A}; \text{B}\}_{\{\text{ACOUT}; \text{BCOUT}\}}$	{A, B} input to {ACOUT, BCOUT} output	0.47	0.53	0.63	0.75	ns
$T_{\text{DSPDO}}\{\text{A}; \text{B}\}_{\text{CARRYCASCOUT\_MULT}}$	{A, B} input to CARRYCASCOUT output using multiplier	3.44	3.94	4.69	5.96	ns
$T_{\text{DSPDO\_D\_CARRYCASCOUT\_MULT}}$	D input to CARRYCASCOUT output using multiplier	3.36	3.85	4.58	5.77	ns
$T_{\text{DSPDO}}\{\text{A}; \text{B}\}_{\text{CARRYCASCOUT}}$	{A, B} input to CARRYCASCOUT output not using multiplier	1.50	1.72	2.04	2.44	ns
$T_{\text{DSPDO\_C\_CARRYCASCOUT}}$	C input to CARRYCASCOUT output	1.34	1.53	1.83	2.18	ns
<b>Combinatorial Delays from Cascading Input Pins to All Output Pins</b>						
$T_{\text{DSPDO\_ACIN\_P\_MULT}}$	ACIN input to P output using multiplier	3.09	3.55	4.24	5.42	ns
$T_{\text{DSPDO\_ACIN\_P}}$	ACIN input to P output not using multiplier	1.16	1.33	1.59	2.07	ns
$T_{\text{DSPDO\_ACIN\_ACOUT}}$	ACIN input to ACOUT output	0.32	0.37	0.45	0.53	ns
$T_{\text{DSPDO\_ACIN\_CARRYCASCOUT\_MULT}}$	ACIN input to CARRYCASCOUT output using multiplier	3.30	3.79	4.52	5.76	ns
$T_{\text{DSPDO\_ACIN\_CARRYCASCOUT}}$	ACIN input to CARRYCASCOUT output not using multiplier	1.37	1.57	1.87	2.40	ns
$T_{\text{DSPDO\_PCIN\_P}}$	PCIN input to P output	0.94	1.08	1.29	1.54	ns
$T_{\text{DSPDO\_PCIN\_CARRYCASCOUT}}$	PCIN input to CARRYCASCOUT output	1.15	1.32	1.57	1.88	ns
<b>Clock to Outs from Output Register Clock to Output Pins</b>						
$T_{\text{DSPCKO\_P\_PREG}}$	CLK PREG to P output	0.33	0.35	0.39	0.45	ns
$T_{\text{DSPCKO\_CARRYCASCOUT\_PREG}}$	CLK PREG to CARRYCASCOUT output	0.44	0.50	0.59	0.71	ns

Table 32: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>Clock to Outs from Pipeline Register Clock to Output Pins</b>						
$T_{\text{DSPCKO\_P\_MREG}}$	CLK MREG to P output	1.42	1.64	1.96	2.31	ns
$T_{\text{DSPCKO\_CARRYCASCOU\_MREG}}$	CLK MREG to CARRYCASCOU output	1.63	1.87	2.24	2.65	ns
$T_{\text{DSPCKO\_P\_ADREG\_MULT}}$	CLK ADREG to P output using multiplier	2.30	2.63	3.13	3.90	ns
$T_{\text{DSPCKO\_CARRYCASCOU\_ADREG\_MULT}}$	CLK ADREG to CARRYCASCOU output using multiplier	2.51	2.87	3.41	4.23	ns
<b>Clock to Outs from Input Register Clock to Output Pins</b>						
$T_{\text{DSPCKO\_P\_AREG\_MULT}}$	CLK AREG to P output using multiplier	3.34	3.83	4.55	5.80	ns
$T_{\text{DSPCKO\_P\_BREG}}$	CLK BREG to P output not using multiplier	1.39	1.59	1.88	2.24	ns
$T_{\text{DSPCKO\_P\_CREG}}$	CLK CREG to P output not using multiplier	1.43	1.64	1.95	2.32	ns
$T_{\text{DSPCKO\_P\_DREG\_MULT}}$	CLK DREG to P output using multiplier	3.32	3.80	4.51	5.74	ns
<b>Clock to Outs from Input Register Clock to Cascading Output Pins</b>						
$T_{\text{DSPCKO\_}\{ACOUT; BCOUT\}\_}\{AREG; BREG\}$	CLK (ACOUT, BCOUT) to {A,B} register output	0.55	0.62	0.74	0.87	ns
$T_{\text{DSPCKO\_CARRYCASCOU\_}\{AREG, BREG\}\_}\text{MULT}$	CLK (AREG, BREG) to CARRYCASCOU output using multiplier	3.55	4.06	4.84	6.13	ns
$T_{\text{DSPCKO\_CARRYCASCOU\_BREG}}$	CLK BREG to CARRYCASCOU output not using multiplier	1.60	1.82	2.16	2.58	ns
$T_{\text{DSPCKO\_CARRYCASCOU\_DREG\_MULT}}$	CLK DREG to CARRYCASCOU output using multiplier	3.52	4.03	4.79	6.07	ns
$T_{\text{DSPCKO\_CARRYCASCOU\_CREG}}$	CLK CREG to CARRYCASCOU output	1.64	1.88	2.23	2.65	ns
<b>Maximum Frequency</b>						
$F_{\text{MAX}}$	With all registers used	741.84	650.20	547.95	429.37	MHz
$F_{\text{MAX\_PATDET}}$	With pattern detector	627.35	549.75	463.61	365.90	MHz
$F_{\text{MAX\_MULT\_NOMREG}}$	Two register multiply without MREG	412.20	360.75	303.77	248.32	MHz
$F_{\text{MAX\_MULT\_NOMREG\_PATDET}}$	Two register multiply without MREG with pattern detect	374.25	327.65	276.01	225.73	MHz
$F_{\text{MAX\_PREADD\_MULT\_NOADREG}}$	Without ADREG	468.82	408.66	342.70	263.44	MHz
$F_{\text{MAX\_PREADD\_MULT\_NOADREG\_PATDET}}$	Without ADREG with pattern detect	468.82	408.66	342.70	263.44	MHz
$F_{\text{MAX\_NOPIPELINEREG}}$	Without pipeline registers (MREG, ADREG)	306.84	267.81	225.02	177.15	MHz
$F_{\text{MAX\_NOPIPELINEREG\_PATDET}}$	Without pipeline registers (MREG, ADREG) with pattern detect	285.23	249.13	209.38	165.32	MHz

## Clock Buffers and Networks

Table 33: Global Clock Switching Characteristics (Including BUFGCTRL)

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
$T_{BCCCK\_CE}/T_{BCCCK\_CE}^{(1)}$	CE pins Setup/Hold	0.12/0.30	0.14/0.38	0.26/0.38	0.23/0.40	ns
$T_{BCCCK\_S}/T_{BCCCK\_S}^{(1)}$	S pins Setup/Hold	0.12/0.30	0.14/0.38	0.26/0.38	0.23/0.40	ns
$T_{BCCCKO\_O}^{(2)}$	BUFGCTRL delay from I0/I1 to O	0.08	0.10	0.12	0.10	ns
<b>Maximum Frequency</b>						
$F_{MAX\_BUFG}$	Global clock tree (BUFG)	741.00	710.00	625.00	560.00	MHz

**Notes:**

- $T_{BCCCK\_CE}$  and  $T_{BCCCK\_S}$  must be satisfied to assure glitch-free operation of the global clock when switching between clocks. These parameters do not apply to the BUFGMUX primitive that assures glitch-free operation. The other global clock setup and hold times are optional; only needing to be satisfied if device operation requires simulation matches on a cycle-for-cycle basis when switching between clocks.
- $T_{BCCCKO\_O}$  (BUFG delay from I0 to O) values are the same as  $T_{BCCCKO\_O}$  values.

Table 34: Input/Output Clock Switching Characteristics (BUFIO)

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
$T_{BIOCKO\_O}$	Clock to out delay from I to O	1.04	1.14	1.32	1.48	ns
<b>Maximum Frequency</b>						
$F_{MAX\_BUFIO}$	I/O clock tree (BUFIO)	800.00	800.00	710.00	710.00	MHz

Table 35: Regional Clock Buffer Switching Characteristics (BUFR)

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
$T_{BRCKO\_O}$	Clock to out delay from I to O	0.60	0.65	0.77	1.06	ns
$T_{BRCKO\_O\_BYP}$	Clock to out delay from I to O with Divide Bypass attribute set	0.30	0.32	0.38	0.57	ns
$T_{BRDO\_O}$	Propagation delay from CLR to O	0.71	0.75	0.96	0.93	ns
<b>Maximum Frequency</b>						
$F_{MAX\_BUFR}^{(1)}$	Regional clock tree (BUFR)	600.00	540.00	450.00	450.00	MHz

**Notes:**

- The maximum input frequency to the BUFR is the BUFIO  $F_{MAX}$  frequency.

Table 36: Horizontal Clock Buffer Switching Characteristics (BUFH)

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
$T_{\text{BHCKO}_O}$	BUFH delay from I to O	0.10	0.11	0.13	0.12	ns
$T_{\text{BHCKC}_CE}/T_{\text{BHCKC}_CE}$	CE pin Setup and Hold	0.20/0.16	0.23/0.20	0.38/0.21	0.28/0.09	ns
<b>Maximum Frequency</b>						
$F_{\text{MAX\_BUFH}}$	Horizontal clock buffer (BUFH)	741.00	710.00	625.00	560.00	MHz

Table 37: Duty Cycle Distortion and Clock-Tree Skew

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
$T_{\text{DCD\_CLK}}$	Global Clock Tree Duty Cycle Distortion <sup>(1)</sup>	All	0.20	0.20	0.20	0.25	ns
$T_{\text{CKSKEW}}$	Global Clock Tree Skew <sup>(2)</sup>	XC7K70T	0.29	0.40	0.40	0.47	ns
		XC7K160T	0.42	0.53	0.57	0.59	ns
		XC7K325T	0.59	0.74	0.79	0.91	ns
		XC7K355T	0.45	0.57	0.59	0.69	ns
		XC7K410T	0.60	0.74	0.79	0.91	ns
		XC7K420T	0.60	0.74	0.79	0.91	ns
		XC7K480T	0.60	0.74	0.79	0.91	ns
$T_{\text{DCD\_BUFIO}}$	I/O clock tree duty cycle distortion	All	0.12	0.12	0.12	0.12	ns
$T_{\text{BUFIOSKEW}}$	I/O clock tree skew across one clock region	All	0.02	0.02	0.02	0.03	ns
$T_{\text{DCD\_BUFR}}$	Regional clock tree duty cycle distortion	All	0.15	0.15	0.15	0.15	ns

**Notes:**

1. These parameters represent the worst-case duty cycle distortion observable at the I/O flip flops. For all I/O standards, IBIS can be used to calculate any additional duty cycle distortion that might be caused by asymmetrical rise/fall times.
2. The  $T_{\text{CKSKEW}}$  value represents the worst-case clock-tree skew observable between sequential I/O elements. Significantly less clock-tree skew exists for I/O registers that are close to each other and fed by the same or adjacent clock-tree branches. Use the Xilinx Timing Analyzer tools to evaluate clock skew specific to your application.

## MMCM Switching Characteristics

Table 38: MMCM Specification

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
MMCM_F <sub>INMAX</sub>	Maximum Input Clock Frequency	1066.00	933.00	800.00	800.00	MHz
MMCM_F <sub>INMIN</sub>	Minimum Input Clock Frequency	10.00	10.00	10.00	10.00	MHz
MMCM_F <sub>INJITTER</sub>	Maximum Input Clock Period Jitter	< 20% of clock input period or 1 ns Max				
MMCM_F <sub>INDUTY</sub>	Allowable Input Duty Cycle: 10—49 MHz	25.00	25.00	25.00	25.00	%
	Allowable Input Duty Cycle: 50—199 MHz	30.00	30.00	30.00	30.00	%
	Allowable Input Duty Cycle: 200—399 MHz	35.00	35.00	35.00	35.00	%
	Allowable Input Duty Cycle: 400—499 MHz	40.00	40.00	40.00	40.00	%
	Allowable Input Duty Cycle: >500 MHz	45.00	45.00	45.00	45.00	%
MMCM_F <sub>MIN_PSCLK</sub>	Minimum Dynamic Phase Shift Clock Frequency	0.01	0.01	0.01	0.01	MHz
MMCM_F <sub>MAX_PSCLK</sub>	Maximum Dynamic Phase Shift Clock Frequency	550.00	500.00	450.00	450.00	MHz
MMCM_F <sub>VCOMIN</sub>	Minimum MMCM VCO Frequency	600.00	600.00	600.00	600.00	MHz
MMCM_F <sub>VCOMAX</sub>	Maximum MMCM VCO Frequency	1600.00	1440.00	1200.00	1200.00	MHz
MMCM_F <sub>BANDWIDTH</sub>	Low MMCM Bandwidth at Typical <sup>(1)</sup>	1.00	1.00	1.00	1.00	MHz
	High MMCM Bandwidth at Typical <sup>(1)</sup>	4.00	4.00	4.00	4.00	MHz
MMCM_T <sub>STATPHAOFFSET</sub>	Static Phase Offset of the MMCM Outputs <sup>(2)</sup>	0.12	0.12	0.12	0.12	ns
MMCM_T <sub>OUTJITTER</sub>	MMCM Output Jitter	Note 3				
MMCM_T <sub>OUTDUTY</sub>	MMCM Output Clock Duty Cycle Precision <sup>(4)</sup>	0.20	0.20	0.20	0.25	ns
MMCM_T <sub>LOCKMAX</sub>	MMCM Maximum Lock Time	100.00	100.00	100.00	100.00	μs
MMCM_F <sub>OUTMAX</sub>	MMCM Maximum Output Frequency	1066.00	933.00	800.00	800.00	MHz
MMCM_F <sub>OUTMIN</sub>	MMCM Minimum Output Frequency <sup>(5)(6)</sup>	4.69	4.69	4.69	4.69	MHz
MMCM_T <sub>EXTFDVAR</sub>	External Clock Feedback Variation	< 20% of clock input period or 1 ns Max				
MMCM_RST <sub>MINPULSE</sub>	Minimum Reset Pulse Width	5.00	5.00	5.00	5.00	ns
MMCM_F <sub>PFDMAX</sub>	Maximum Frequency at the Phase Frequency Detector with Bandwidth Set to High or Optimized	550.00	500.00	450.00	450.00	MHz
	Maximum Frequency at the Phase Frequency Detector with Bandwidth Set to Low	300.00	300.00	300.00	300.00	MHz
MMCM_F <sub>PFDMIN</sub>	Minimum Frequency at the Phase Frequency Detector	10.00	10.00	10.00	10.00	MHz
MMCM_T <sub>FBDELAY</sub>	Maximum Delay in the Feedback Path	3 ns Max or one CLKIN cycle				
<b>MMCM Switching Characteristics Setup and Hold</b>						
T <sub>MMCMDCK_PSEN</sub> / T <sub>MMCMCKD_PSEN</sub>	Setup and Hold of Phase Shift Enable	1.04/0.00	1.04/0.00	1.04/0.00	1.04/0.00	ns
T <sub>MMCMDCK_PSINCDEC</sub> / T <sub>MMCMCKD_PSINCDEC</sub>	Setup and Hold of Phase Shift Increment/Decrement	1.04/0.00	1.04/0.00	1.04/0.00	1.04/0.00	ns
T <sub>MMCMCKO_PSDONE</sub>	Phase Shift Clock-to-Out of PSDONE	0.59	0.68	0.81	0.78	ns
<b>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</b>						
T <sub>MMCMDCK_DADDR</sub> / T <sub>MMCMCKD_DADDR</sub>	DADDR Setup/Hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>MMCMDCK_DI</sub> / T <sub>MMCMCKD_DI</sub>	DI Setup/Hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min

Table 38: MMCM Specification (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
$T_{MMCMCK\_DEN}/T_{MMCMCKD\_DEN}$	DEN Setup/Hold	1.76/0.00	1.97/0.00	2.29/0.00	2.40/0.00	ns, Min
$T_{MMCMCK\_DWE}/T_{MMCMCKD\_DWE}$	DWE Setup/Hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
$T_{MMCMCKO\_DRDY}$	CLK to out of DRDY	0.65	0.72	0.99	0.70	ns, Max
$F_{DCK}$	DCLK frequency	200.00	200.00	200.00	100.00	MHz, Max

**Notes:**

1. The MMCM does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
2. The static offset is measured between any MMCM outputs with identical phase.
3. Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
4. Includes global clock buffer.
5. Calculated as  $F_{VCO}/128$  assuming output duty cycle is 50%.
6. When  $CLKOUT4\_CASCADE = TRUE$ ,  $MMCM\_F_{OUTMIN}$  is 0.036 MHz.

**PLL Switching Characteristics**

Table 39: PLL Specification

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
$PLL\_F_{INMAX}$	Maximum Input Clock Frequency	1066.00	933.00	800.00	800.00	MHz
$PLL\_F_{INMIN}$	Minimum Input Clock Frequency	19.00	19.00	19.00	19.00	MHz
$PLL\_F_{INJITTER}$	Maximum Input Clock Period Jitter	< 20% of clock input period or 1 ns Max				
$PLL\_F_{INDUTY}$	Allowable Input Duty Cycle: 19—49 MHz	25.00	25.00	25.00	25.00	%
	Allowable Input Duty Cycle: 50—199 MHz	30.00	30.00	30.00	30.00	%
	Allowable Input Duty Cycle: 200—399 MHz	35.00	35.00	35.00	35.00	%
	Allowable Input Duty Cycle: 400—499 MHz	40.00	40.00	40.00	40.00	%
	Allowable Input Duty Cycle: >500 MHz	45.00	45.00	45.00	45.00	%
$PLL\_F_{VCOMIN}$	Minimum PLL VCO Frequency	800.00	800.00	800.00	800.00	MHz
$PLL\_F_{VCOMAX}$	Maximum PLL VCO Frequency	2133.00	1866.00	1600.00	1600.00	MHz
$PLL\_F_{BANDWIDTH}$	Low PLL Bandwidth at Typical <sup>(1)</sup>	1.00	1.00	1.00	1.00	MHz
	High PLL Bandwidth at Typical <sup>(1)</sup>	4.00	4.00	4.00	4.00	MHz
$PLL\_T_{STATPHAOFFSET}$	Static Phase Offset of the PLL Outputs <sup>(2)</sup>	0.12	0.12	0.12	0.12	ns
$PLL\_T_{OUTJITTER}$	PLL Output Jitter	Note 3				
$PLL\_T_{OUTDUTY}$	PLL Output Clock Duty Cycle Precision <sup>(4)</sup>	0.20	0.20	0.20	0.25	ns
$PLL\_T_{LOCKMAX}$	PLL Maximum Lock Time	100	100	100	100	μs
$PLL\_F_{OUTMAX}$	PLL Maximum Output Frequency	1066.00	933.00	800.00	800.00	MHz
$PLL\_F_{OUTMIN}$	PLL Minimum Output Frequency <sup>(5)</sup>	6.25	6.25	6.25	6.25	MHz
$PLL\_T_{EXTFDVAR}$	External Clock Feedback Variation	< 20% of clock input period or 1 ns Max				
$PLL\_RST_{MINPULSE}$	Minimum Reset Pulse Width	5.00	5.00	5.00	5.00	ns

**Table 39: PLL Specification (Cont'd)**

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
PLL_FPFDMAX	Maximum Frequency at the Phase Frequency Detector with Bandwidth Set to High or Optimized	550.00	500.00	450.00	450.00	MHz
	Maximum Frequency at the Phase Frequency Detector with Bandwidth Set to Low	300.00	300.00	300.00	300.00	MHz
PLL_FPFDMIN	Minimum Frequency at the Phase Frequency Detector	19.00	19.00	19.00	19.00	MHz
PLL_TFBDELAY	Maximum Delay in the Feedback Path	3 ns Max or one CLKIN cycle				
<b>Dynamic Reconfiguration Port (DRP) for PLL Before and After DCLK</b>						
T <sub>PLLCKC_DADDR</sub> / T <sub>PLLCKC_DADDR</sub>	Setup and hold of D address	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLCKC_DI</sub> / T <sub>PLLCKC_DI</sub>	Setup and hold of D input	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLCKC_DEN</sub> / T <sub>PLLCKC_DEN</sub>	Setup and hold of D enable	1.76/0.00	1.97/0.00	2.29/0.00	2.40/0.00	ns, Min
T <sub>PLLCKC_DWE</sub> / T <sub>PLLCKC_DWE</sub>	Setup and hold of D write enable	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLCKO_DRDY</sub>	CLK to out of DRDY	0.65	0.72	0.99	0.70	ns, Max
F <sub>DCK</sub>	DCLK frequency	200.00	200.00	200.00	100.00	MHz, Max

**Notes:**

1. The PLL does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
2. The static offset is measured between any PLL outputs with identical phase.
3. Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
4. Includes global clock buffer.
5. Calculated as  $F_{VCO}/128$  assuming output duty cycle is 50%.



## Device Pin-to-Pin Output Parameter Guidelines

All devices are 100% functionally tested. Values are expressed in nanoseconds unless otherwise noted.

Table 40: Clock-Capable Clock Input to Output Delay Without MMCM/PLL (Near Clock Region)

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>without</i> MMCM/PLL.							
T <sub>ICKOF</sub>	Clock-capable clock input and OUTFF <i>without</i> MMCM/PLL (near clock region)	XC7K70T	4.98	5.49	6.17	7.04	ns
		XC7K160T	5.23	5.77	6.48	7.38	ns
		XC7K325T	5.72	6.31	7.09	8.07	ns
		XC7K355T	5.34	5.87	6.57	7.51	ns
		XC7K410T	5.84	6.44	7.22	8.21	ns
		XC7K420T	5.50	6.04	6.77	7.73	ns
		XC7K480T	5.50	6.04	6.77	7.73	ns

**Notes:**

- Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

Table 41: Clock-Capable Clock Input to Output Delay Without MMCM/PLL (Far Clock Region)

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>without</i> MMCM/PLL.							
T <sub>ICKOFFAR</sub>	Clock-capable clock input and OUTFF <i>without</i> MMCM/PLL (far clock region)	XC7K70T	5.29	5.83	6.55	7.47	ns
		XC7K160T	5.84	6.45	7.24	8.24	ns
		XC7K325T	6.33	6.99	7.84	8.92	ns
		XC7K355T	5.95	6.55	7.32	8.36	ns
		XC7K410T	6.45	7.12	7.97	9.07	ns
		XC7K420T	6.41	7.06	7.90	9.01	ns
		XC7K480T	6.41	7.06	7.90	9.01	ns

**Notes:**

- Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

Table 42: Clock-Capable Clock Input to Output Delay With MMCM

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, with MMCM.							
T <sub>ICKOFMMCMCC</sub>	Clock-capable clock input and OUTFF with MMCM	XC7K70T	0.95	0.95	0.95	1.74	ns
		XC7K160T	0.96	0.96	0.96	1.78	ns
		XC7K325T	1.00	1.00	1.00	1.82	ns
		XC7K355T	1.00	1.00	1.00	1.78	ns
		XC7K410T	1.00	1.00	1.00	1.82	ns
		XC7K420T	1.07	1.07	1.07	1.82	ns
		XC7K480T	1.07	1.07	1.07	1.82	ns

Notes:

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. MMCM output jitter is already included in the timing calculation.

Table 43: Clock-Capable Clock Input to Output Delay With PLL

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, with PLL.							
T <sub>ICKOFPLLCC</sub>	Clock-capable clock input and OUTFF with PLL	XC7K70T	0.84	0.84	0.84	1.45	ns
		XC7K160T	0.89	0.89	0.89	1.54	ns
		XC7K325T	0.89	0.89	0.89	1.54	ns
		XC7K355T	0.89	0.89	0.89	1.50	ns
		XC7K410T	0.89	0.89	0.89	1.54	ns
		XC7K420T	0.96	0.96	0.96	1.54	ns
		XC7K480T	0.96	0.96	0.96	1.54	ns

Notes:

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. PLL output jitter is already included in the timing calculation.

Table 44: Pin-to-Pin, Clock-to-Out using BUFIO

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, with BUFIO.						
T <sub>ICKOFCS</sub>	Clock-to-Out of I/O clock for HR I/O banks	4.93	5.52	6.20	6.97	ns
	Clock-to-Out of I/O clock for HP I/O banks	4.85	5.44	6.11	6.90	ns

## Device Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. Values are expressed in nanoseconds unless otherwise noted.

Table 45: Global Clock Input Setup and Hold Without MMCM/PLL with ZHOLD\_DELAY on HR I/O Banks

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>							
T <sub>PSFD</sub> / T <sub>PHFD</sub>	Full Delay (Legacy Delay or Default Delay) Global Clock Input and IFF <sup>(2)</sup> without MMCM/PLL with ZHOLD_DELAY on HR I/O Banks	XC7K70T	2.83/-0.29	2.95/-0.29	3.15/-0.29	4.96/-0.33	ns
		XC7K160T	3.17/-0.35	3.29/-0.35	3.55/-0.35	5.54/-0.49	ns
		XC7K325T	2.83/-0.06	2.94/-0.06	3.15/-0.06	5.18/-0.14	ns
		XC7K355T	3.26/-0.32	3.41/-0.32	3.67/-0.32	5.84/-0.49	ns
		XC7K410T	3.43/-0.34	3.59/-0.34	3.88/-0.34	6.21/-0.54	ns
		XC7K420T	3.37/-0.27	3.48/-0.27	3.76/-0.27	6.00/-0.52	ns
		XC7K480T	3.37/-0.27	3.48/-0.27	3.76/-0.27	6.00/-0.52	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. A Zero "0" Hold Time listing indicates no hold time or a negative hold time.

Table 46: Clock-Capable Clock Input Setup and Hold With MMCM

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>							
T <sub>PSMMCMCC</sub> / T <sub>PHMMCMCC</sub>	No Delay clock-capable clock input and IFF <sup>(2)</sup> with MMCM	XC7K70T	2.39/-0.22	2.65/-0.22	2.94/-0.22	2.21/-0.44	ns
		XC7K160T	2.49/-0.20	2.77/-0.20	3.07/-0.20	2.38/-0.47	ns
		XC7K325T	2.55/-0.16	2.85/-0.16	3.14/-0.16	2.60/-0.47	ns
		XC7K355T	2.43/-0.16	2.73/-0.16	3.00/-0.16	2.47/-0.43	ns
		XC7K410T	2.55/-0.16	2.84/-0.16	3.14/-0.16	2.58/-0.47	ns
		XC7K420T	2.47/-0.09	2.73/-0.09	3.02/-0.09	2.40/-0.41	ns
		XC7K480T	2.47/-0.09	2.73/-0.09	3.02/-0.09	2.40/-0.41	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 47: Clock-Capable Clock Input Setup and Hold With PLL

Symbol	Description	Device	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to Clock-Capable Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>							
T <sub>PSPLLCC</sub> / T <sub>PHPLLCC</sub>	No Delay clock-capable clock input and IFF <sup>(2)</sup> with PLL	XC7K70T	2.75/-0.32	3.04/-0.32	3.33/-0.32	2.42/-0.54	ns
		XC7K160T	2.85/-0.31	3.16/-0.31	3.46/-0.31	2.59/-0.56	ns
		XC7K325T	2.91/-0.27	3.24/-0.27	3.54/-0.27	2.80/-0.56	ns
		XC7K355T	2.79/-0.27	3.12/-0.27	3.40/-0.27	2.67/-0.52	ns
		XC7K410T	2.91/-0.27	3.24/-0.27	3.53/-0.27	2.78/-0.56	ns
		XC7K420T	2.83/-0.20	3.12/-0.20	3.41/-0.20	2.61/-0.50	ns
		XC7K480T	2.83/-0.20	3.12/-0.20	3.41/-0.20	2.61/-0.50	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 48: Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFIO

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to a Forwarded Clock Input Pin Using BUFIO for SSTL15 Standard.						
T <sub>PSCS</sub> /T <sub>PHCS</sub>	Setup/Hold of I/O clock for HR I/O banks	-0.36/1.36	-0.36/1.50	-0.36/1.70	-0.44/1.87	ns
	Setup/Hold of I/O clock for HP I/O banks	-0.34/1.39	-0.34/1.53	-0.34/1.73	-0.44/1.87	ns

Table 49: Sample Window

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
T <sub>SAMP</sub>	Sampling Error at Receiver Pins <sup>(1)</sup>	0.51	0.56	0.61	0.56	ns
T <sub>SAMP_BUFIO</sub>	Sampling Error at Receiver Pins using BUFIO <sup>(2)</sup>	0.30	0.35	0.40	0.35	ns

**Notes:**

1. This parameter indicates the total sampling error of the Kintex-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the MMCM to capture the DDR input registers' edges of operation. These measurements include:
  - CLK0 MMCM jitter
  - MMCM accuracy (phase offset)
  - MMCM phase shift resolution
 These measurements do not include package or clock tree skew.
2. This parameter indicates the total sampling error of the Kintex-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the BUFIO clock network and IDELAY to capture the DDR input registers' edges of operation. These measurements do not include package or clock tree skew.

## Additional Package Parameter Guidelines

The parameters in this section provide the necessary values for calculating timing budgets for Kintex-7 FPGA clock transmitter and receiver data-valid windows.

Table 50: Package Skew

Symbol	Description	Device	Package	Value	Units	
T <sub>PKGSKEW</sub>	Package Skew <sup>(1)</sup>	XC7K70T	FBG484	108	ps	
			FBG676	135	ps	
		XC7K160T	FBG484	118	ps	
			FBG676	136	ps	
			FFG676	161	ps	
		XC7K325T	FBG676	146	ps	
			FFG676	154	ps	
			FBG900	163	ps	
			FFG900	161	ps	
		XC7K355T		FFG901	149	ps
		XC7K410T	FBG676	165	ps	
			FFG676	168	ps	
			FBG900	151	ps	
			FFG900	146	ps	
		XC7K420T	FFG901	149	ps	
			FFG1156	145	ps	
		XC7K480T	FFG901	149	ps	
			FFG1156	145	ps	

### Notes:

1. These values represent the worst-case skew between any two SelectIO resources in the package: shortest delay to longest delay from die pad to ball.
2. Package delay information is available for these device/package combinations. This information can be used to deskew the package.

# GTX Transceiver Specifications

## GTX Transceiver DC Input and Output Levels

Table 51 summarizes the DC output specifications of the GTX transceivers in Kintex-7 FPGAs. Consult [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#) for further details.

Table 51: GTX Transceiver DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
DV <sub>PPOUT</sub>	Differential peak-to-peak output voltage <sup>(1)</sup>	Transmitter output swing is set to maximum setting	–	–	1000	mV
V <sub>CMOUTDC</sub>	DC common mode output voltage.	Equation based	$V_{MGTAVTT} - DV_{PPOUT}/4$			mV
R <sub>OUT</sub>	Differential output resistance		–	100	–	Ω
T <sub>OSKEW</sub>	Transmitter output pair (TXP and TXN) intra-pair skew		–	2	12	ps
DV <sub>PPIN</sub>	Differential peak-to-peak input voltage (external AC coupled)	>10.3125 Gb/s	150	–	1250	mV
		6.6 Gb/s to 10.3125 Gb/s	150	–	1250	mV
		≤ 6.6 Gb/s	150	–	2000	mV
V <sub>IN</sub>	Absolute input voltage	DC coupled V <sub>MGTAVTT</sub> = 1.2V	–200	–	V <sub>MGTAVTT</sub>	mV
V <sub>CMIN</sub>	Common mode input voltage	DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	2/3 V <sub>MGTAVTT</sub>	–	mV
R <sub>IN</sub>	Differential input resistance		–	100	–	Ω
C <sub>EXT</sub>	Recommended external AC coupling capacitor <sup>(2)</sup>		–	100	–	nF

**Notes:**

1. The output swing and preemphasis levels are programmable using the attributes discussed in [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#) and can result in values lower than reported in this table.
2. Other values can be used as appropriate to conform to specific protocols and standards.

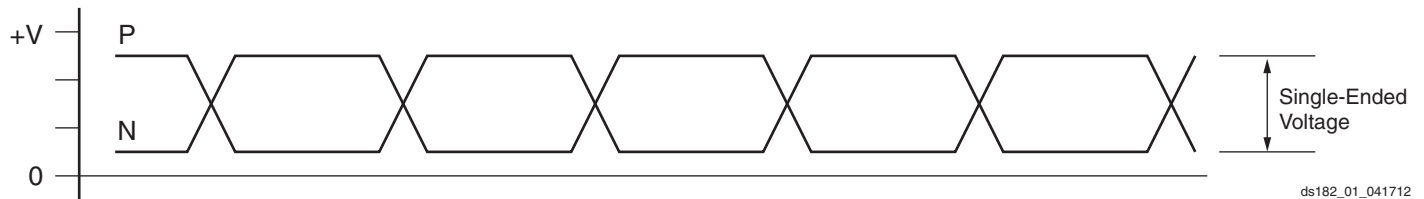


Figure 1: Single-Ended Peak-to-Peak Voltage

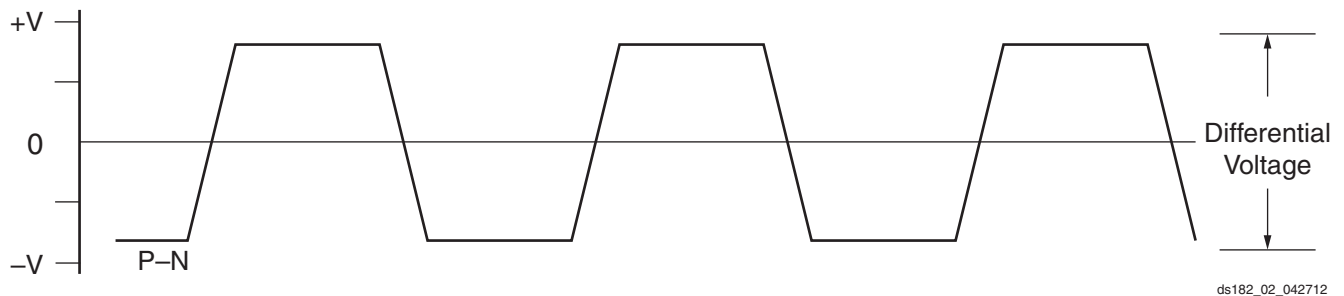


Figure 2: Differential Peak-to-Peak Voltage

Table 52 summarizes the DC specifications of the clock input of the GTX transceiver. Consult [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#) for further details.

Table 52: GTX Transceiver Clock DC Input Level Specification

Symbol	DC Parameter	Min	Typ	Max	Units
V <sub>IDIFF</sub>	Differential peak-to-peak input voltage	250	–	2000	mV
R <sub>IN</sub>	Differential input resistance	–	100	–	Ω
C <sub>EXT</sub>	Required external AC coupling capacitor	–	100	–	nF

### GTX Transceiver Switching Characteristics

Consult [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#) for further information.

Table 53: GTX Transceiver Performance

Symbol	Description	Output Divider	Speed Grade								Units
			1.0V				0.9V				
			-3		-2/-2L		-1 <sup>(1)</sup>		-2L <sup>(2)</sup>		
			Package Type								
			FF	FB	FF	FB	FF	FB	FF	FB	
F <sub>GTXMAX</sub> <sup>(3)</sup>	Maximum GTX transceiver data rate		12.5	6.6	10.3125	6.6	8.0	6.6	6.6	6.6	Gb/s
F <sub>GTXMIN</sub> <sup>(3)</sup>	Minimum GTX transceiver data rate		0.500	0.500	0.500	0.500	0.500	0.500	0.500	0.500	Gb/s
F <sub>GTXCRANGE</sub>	CPLL line rate range	1	3.2–6.6								Gb/s
		2	1.6–3.3								Gb/s
		4	0.8–1.65								Gb/s
		8	0.5–0.825								Gb/s
		16	N/A								Gb/s
F <sub>GTXQRANGE1</sub>	QPLL line rate range 1	1	5.93–8.0	5.93–6.6	5.93–8.0	5.93–6.6	5.93–8.0	5.93–6.6	5.93–6.6		Gb/s
		2	2.965–4.0		2.965–4.0		2.965–4.0		2.965–3.3		Gb/s
		4	1.4825–2.0		1.4825–2.0		1.4825–2.0		1.4825–1.65		Gb/s
		8	0.74125–1.0		0.74125–1.0		0.74125–1.0		0.74125–0.825		Gb/s
		16	N/A		N/A		N/A		N/A		Gb/s
F <sub>GTXQRANGE2</sub>	QPLL line rate range 2 <sup>(4)</sup>	1	9.8–12.5	N/A	9.8–10.3125	N/A	N/A		N/A		Gb/s
		2	4.9–6.25		4.9–5.15625		N/A		N/A		Gb/s
		4	2.45–3.125		2.45–2.578125		N/A		N/A		Gb/s
		8	1.225–1.5625		1.225–1.2890625		N/A		N/A		Gb/s
		16	0.6125–0.78125		0.6125–0.64453125		N/A		N/A		Gb/s
F <sub>GCPLL</sub> RANGE	GTX transceiver CPLL frequency range		1.6–3.3		1.6–3.3		1.6–3.3		1.6–3.3		GHz
F <sub>GQPLL</sub> RANGE1	GTX transceiver QPLL frequency range 1		5.93–8.0		5.93–8.0		5.93–8.0		5.93–6.6		GHz

Table 53: GTX Transceiver Performance (Cont'd)

Symbol	Description	Output Divider	Speed Grade								Units
			1.0V				0.9V				
			-3		-2/-2L		-1 <sup>(1)</sup>		-2L <sup>(2)</sup>		
			Package Type								
			FF	FB	FF	FB	FF	FB	FF	FB	
F <sub>GQPLL</sub> RANGE2	GTX transceiver QPLL frequency range 2		9.8–12.5		9.8–10.3125		N/A		N/A		GHz

Notes:

1. The -1 speed grade requires a 4-byte internal data width for operation above 5.0 Gb/s.
2. The -2L (0.9V) speed grade requires a 4-byte internal data width for operation above 3.8 Gb/s.
3. Data rates between 8.0 Gb/s and 9.8 Gb/s are not available.
4. For QPLL line rate range 2, the maximum line rate with the divider N set to 66 is 10.3125Gb/s.

Table 54: GTX Transceiver Dynamic Reconfiguration Port (DRP) Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
F <sub>GTXDRPCLK</sub>	GTXDRPCLK maximum frequency	175.01	175.01	156.25	125.00	MHz

Table 55: GTX Transceiver Reference Clock Switching Characteristics

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
F <sub>GCLK</sub>	Reference clock frequency range	-3 speed grade	60	–	700	MHz
		All other speed grades	60	–	670	MHz
T <sub>RCLK</sub>	Reference clock rise time	20% – 80%	–	200	–	ps
T <sub>FCLK</sub>	Reference clock fall time	80% – 20%	–	200	–	ps
T <sub>DCREF</sub>	Reference clock duty cycle	Transceiver PLL only	40	50	60	%

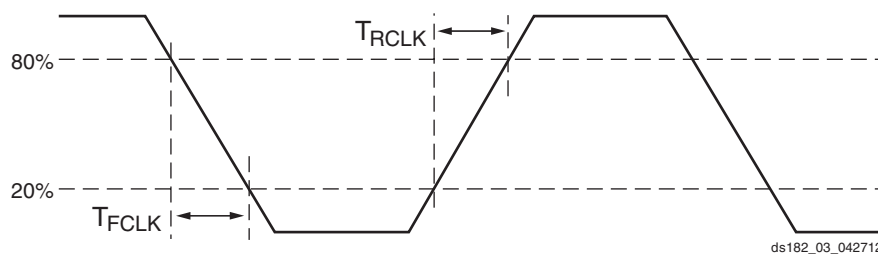


Figure 3: Reference Clock Timing Parameters



Table 56: GTX Transceiver PLL /Lock Time Adaptation

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
T <sub>LOCK</sub>	Initial PLL lock		–	–	1	ms
T <sub>DLOCK</sub>	Clock recovery phase acquisition and adaptation time for decision feedback equalizer (DFE).	After the PLL is locked to the reference clock, this is the time it takes to lock the clock data recovery (CDR) to the data present at the input.	–	50,000	37 x10 <sup>6</sup>	UI
	Clock recovery phase acquisition and adaptation time for low-power mode (LPM) when the DFE is disabled.		–	50,000	2.3 x10 <sup>6</sup>	UI

Table 57: GTX Transceiver User Clock Switching Characteristics<sup>(1)(2)</sup>

Symbol	Description	Conditions	Speed Grade				Units
			1.0V			0.9V	
			-3 <sup>(3)</sup>	-2/-2L <sup>(3)</sup>	-1 <sup>(4)</sup>	-2L <sup>(5)</sup>	
F <sub>TXOUT</sub>	TXOUTCLK maximum frequency		412.54	412.54	312.50	237.53	MHz
F <sub>RXOUT</sub>	RXOUTCLK maximum frequency		412.54	412.54	312.50	237.53	MHz
F <sub>TXIN</sub>	TXUSRCLK maximum frequency	16-bit data path	412.54	412.54	312.50	237.53	MHz
		32-bit data path	391.08	322.37	250.00	206.27	MHz
F <sub>RXIN</sub>	RXUSRCLK maximum frequency	16-bit data path	412.54	412.54	312.50	237.53	MHz
		32-bit data path	391.08	322.37	250.00	206.27	MHz
F <sub>TXIN2</sub>	TXUSRCLK2 maximum frequency	16-bit data path	412.54	412.54	312.50	237.53	MHz
		32-bit data path	391.08	322.37	250.00	206.27	MHz
		64-bit data path	195.54	161.19	125.00	103.14	MHz
F <sub>RXIN2</sub>	RXUSRCLK2 maximum frequency	16-bit data path	412.54	412.54	312.50	237.53	MHz
		32-bit data path	391.08	322.37	250.00	206.27	MHz
		64-bit data path	195.54	161.19	125.00	103.14	MHz

Notes:

1. Clocking must be implemented as described in [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#).
2. These frequencies are not supported for all possible transceiver configurations.
3. For speed grades -3, -2, -2L (1.0V), a 16-bit data path can only be used for speeds less than 6.6 Gb/s.
4. For speed grade -1, a 16-bit data path can only be used for speeds less than 5.0 Gb/s.
5. For speed grade -2L (0.9V), a 16-bit data path can only be used for speeds less than 3.8 Gb/s.

Table 58: GTX Transceiver Transmitter Switching Characteristics

Symbol	Description	Condition	Min	Typ	Max	Units
F <sub>GTXTX</sub>	Serial data rate range		0.500	–	F <sub>GTXTXMAX</sub>	Gb/s
T <sub>RTX</sub>	TX Rise time	20%–80%	–	40	–	ps
T <sub>FTX</sub>	TX Fall time	80%–20%	–	40	–	ps
T <sub>LLSKEW</sub>	TX lane-to-lane skew <sup>(1)</sup>		–	–	500	ps
V <sub>TXOOBVDDP</sub>	Electrical idle amplitude		–	–	15	mV
T <sub>TXOOBTRANSITION</sub>	Electrical idle transition time		–	–	140	ns
T <sub>J12.5</sub>	Total Jitter <sup>(2)(4)</sup>	12.5 Gb/s	–	–	0.28	UI
D <sub>J12.5</sub>	Deterministic Jitter <sup>(2)(4)</sup>		–	–	0.17	UI
T <sub>J11.18</sub>	Total Jitter <sup>(2)(4)</sup>	11.18 Gb/s	–	–	0.28	UI
D <sub>J11.18</sub>	Deterministic Jitter <sup>(2)(4)</sup>		–	–	0.17	UI

**Table 58: GTX Transceiver Transmitter Switching Characteristics (Cont'd)**

Symbol	Description	Condition	Min	Typ	Max	Units
TJ <sub>10.3125</sub>	Total Jitter <sup>(2)(4)</sup>	10.3125 Gb/s	–	–	0.28	UI
DJ <sub>10.3125</sub>	Deterministic Jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>9.953</sub>	Total Jitter <sup>(2)(4)</sup>	9.953 Gb/s	–	–	0.28	UI
DJ <sub>9.953</sub>	Deterministic Jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>9.8</sub>	Total Jitter <sup>(2)(4)</sup>	9.8 Gb/s	–	–	0.28	UI
DJ <sub>9.8</sub>	Deterministic Jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>8.0</sub>	Total Jitter <sup>(2)(4)</sup>	8.0 Gb/s	–	–	0.30	UI
DJ <sub>8.0</sub>	Deterministic Jitter <sup>(2)(4)</sup>		–	–	0.15	UI
TJ <sub>6.6_QPLL</sub>	Total Jitter <sup>(2)(4)</sup>	6.6 Gb/s	–	–	0.28	UI
DJ <sub>6.6_QPLL</sub>	Deterministic Jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>6.6_CPLL</sub>	Total Jitter <sup>(3)(4)</sup>	6.6 Gb/s	–	–	0.30	UI
DJ <sub>6.6_CPLL</sub>	Deterministic Jitter <sup>(3)(4)</sup>		–	–	0.15	UI
TJ <sub>5.0</sub>	Total Jitter <sup>(3)(4)</sup>	5.0 Gb/s	–	–	0.30	UI
DJ <sub>5.0</sub>	Deterministic Jitter <sup>(3)(4)</sup>		–	–	0.15	UI
TJ <sub>4.25</sub>	Total Jitter <sup>(3)(4)</sup>	4.25 Gb/s	–	–	0.30	UI
DJ <sub>4.25</sub>	Deterministic Jitter <sup>(3)(4)</sup>		–	–	0.15	UI
TJ <sub>3.75</sub>	Total Jitter <sup>(3)(4)</sup>	3.75 Gb/s	–	–	0.30	UI
DJ <sub>3.75</sub>	Deterministic Jitter <sup>(3)(4)</sup>		–	–	0.15	UI
TJ <sub>3.2</sub>	Total Jitter <sup>(3)(4)</sup>	3.20 Gb/s <sup>(5)</sup>	–	–	0.2	UI
DJ <sub>3.2</sub>	Deterministic Jitter <sup>(3)(4)</sup>		–	–	0.1	UI
TJ <sub>3.2L</sub>	Total Jitter <sup>(3)(4)</sup>	3.20 Gb/s <sup>(6)</sup>	–	–	0.32	UI
DJ <sub>3.2L</sub>	Deterministic Jitter <sup>(3)(4)</sup>		–	–	0.16	UI
TJ <sub>2.5</sub>	Total Jitter <sup>(3)(4)</sup>	2.5 Gb/s <sup>(7)</sup>	–	–	0.20	UI
DJ <sub>2.5</sub>	Deterministic Jitter <sup>(3)(4)</sup>		–	–	0.08	UI
TJ <sub>1.25</sub>	Total Jitter <sup>(3)(4)</sup>	1.25 Gb/s <sup>(8)</sup>	–	–	0.15	UI
DJ <sub>1.25</sub>	Deterministic Jitter <sup>(3)(4)</sup>		–	–	0.06	UI
TJ <sub>500</sub>	Total Jitter <sup>(3)(4)</sup>	500 Mb/s	–	–	0.1	UI
DJ <sub>500</sub>	Deterministic Jitter <sup>(3)(4)</sup>		–	–	0.03	UI

**Notes:**

- Using same REFCLK input with TX phase alignment enabled for up to 12 consecutive transmitters (three fully populated GTX Quads).
- Using QPLL\_FBDIV = 40, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
- Using CPLL\_FBDIV = 2, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
- All jitter values are based on a bit-error ratio of  $1e^{-12}$ .
- CPLL frequency at 3.2 GHz and TXOUT\_DIV = 2.
- CPLL frequency at 1.6 GHz and TXOUT\_DIV = 1.
- CPLL frequency at 2.5 GHz and TXOUT\_DIV = 2.
- CPLL frequency at 2.5 GHz and TXOUT\_DIV = 4.

**Table 59: GTX Transceiver Receiver Switching Characteristics**

Symbol	Description		Min	Typ	Max	Units
F <sub>GTXR</sub>	Serial data rate	RX oversampler not enabled	0.500	–	F <sub>GTXMAX</sub>	Gb/s
T <sub>RXELECIDLE</sub>	Time for RXELEC_IDLE to respond to loss or restoration of data		–	10	–	ns
RX <sub>OOBVDPP</sub>	OOB detect threshold peak-to-peak		60	–	150	mV
RX <sub>SST</sub>	Receiver spread-spectrum tracking <sup>(1)</sup>	Modulated @ 33 KHz	–5000	–	0	ppm
RX <sub>RL</sub>	Run length (CID)		–	–	512	UI
RX <sub>PPMTOL</sub>	Data/REFCLK PPM offset tolerance	Bit rates ≤ 6.6 Gb/s	–1250	–	1250	ppm
		Bit rates > 6.6 Gb/s and ≤ 8.0 Gb/s	–700	–	700	ppm
		Bit rates > 8.0 Gb/s	–200	–	200	ppm
<b>SJ Jitter Tolerance<sup>(2)</sup></b>						
JT_SJ <sub>12.5</sub>	Sinusoidal Jitter (QPLL) <sup>(3)</sup>	12.5 Gb/s	0.3	–	–	UI
JT_SJ <sub>11.18</sub>	Sinusoidal Jitter (QPLL) <sup>(3)</sup>	11.18 Gb/s	0.3	–	–	UI
JT_SJ <sub>10.32</sub>	Sinusoidal Jitter (QPLL) <sup>(3)</sup>	10.32 Gb/s	0.3	–	–	UI
JT_SJ <sub>9.95</sub>	Sinusoidal Jitter (QPLL) <sup>(3)</sup>	9.95 Gb/s	0.3	–	–	UI
JT_SJ <sub>9.8</sub>	Sinusoidal Jitter (QPLL) <sup>(3)</sup>	9.8 Gb/s	0.3	–	–	UI
JT_SJ <sub>8.0</sub>	Sinusoidal Jitter (QPLL) <sup>(3)</sup>	8.0 Gb/s	0.44	–	–	UI
JT_SJ <sub>6.6_QPLL</sub>	Sinusoidal Jitter (QPLL) <sup>(3)</sup>	6.6 Gb/s	0.48	–	–	UI
JT_SJ <sub>6.6_CPLL</sub>	Sinusoidal Jitter (CPLL) <sup>(3)</sup>	6.6 Gb/s	0.44	–	–	UI
JT_SJ <sub>5.0</sub>	Sinusoidal Jitter (CPLL) <sup>(3)</sup>	5.0 Gb/s	0.44	–	–	UI
JT_SJ <sub>4.25</sub>	Sinusoidal Jitter (CPLL) <sup>(3)</sup>	4.25 Gb/s	0.44	–	–	UI
JT_SJ <sub>3.75</sub>	Sinusoidal Jitter (CPLL) <sup>(3)</sup>	3.75 Gb/s	0.44	–	–	UI
JT_SJ <sub>3.2</sub>	Sinusoidal Jitter (CPLL) <sup>(3)</sup>	3.2 Gb/s <sup>(4)</sup>	0.45	–	–	UI
JT_SJ <sub>3.2L</sub>	Sinusoidal Jitter (CPLL) <sup>(3)</sup>	3.2 Gb/s <sup>(5)</sup>	0.45	–	–	UI
JT_SJ <sub>2.5</sub>	Sinusoidal Jitter (CPLL) <sup>(3)</sup>	2.5 Gb/s <sup>(6)</sup>	0.5	–	–	UI
JT_SJ <sub>1.25</sub>	Sinusoidal Jitter (CPLL) <sup>(3)</sup>	1.25 Gb/s <sup>(7)</sup>	0.5	–	–	UI
JT_SJ <sub>500</sub>	Sinusoidal Jitter (CPLL) <sup>(3)</sup>	500 Mb/s	0.4	–	–	UI
<b>SJ Jitter Tolerance with Stressed Eye<sup>(2)</sup></b>						
JT_TJSE <sub>3.2</sub>	Total Jitter with Stressed Eye <sup>(8)</sup>	3.2 Gb/s	0.70	–	–	UI
JT_TJSE <sub>6.6</sub>		6.6 Gb/s	0.70	–	–	UI
JT_SJSE <sub>3.2</sub>	Sinusoidal Jitter with Stressed Eye <sup>(8)</sup>	3.2 Gb/s	0.1	–	–	UI
JT_SJSE <sub>6.6</sub>		6.6 Gb/s	0.1	–	–	UI

**Notes:**

- Using RXOUT\_DIV = 1, 2, and 4.
- All jitter values are based on a bit error ratio of 1e<sup>-12</sup>.
- The frequency of the injected sinusoidal jitter is 10 MHz.
- CPLL frequency at 3.2 GHz and RXOUT\_DIV = 2.
- CPLL frequency at 1.6 GHz and RXOUT\_DIV = 1.
- CPLL frequency at 2.5 GHz and RXOUT\_DIV = 2.
- CPLL frequency at 2.5 GHz and RXOUT\_DIV = 4.
- Composite jitter with RX and LPM or DFE mode.

## GTX Transceiver Protocol Jitter Characteristics

For Table 60 through Table 65, the [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#) contains recommended settings for optimal usage of protocol specific characteristics.

Table 60: Gigabit Ethernet Protocol Characteristics

Description	Line Rate (Mb/s)	Min	Max	Units
<b>Gigabit Ethernet Transmitter Jitter Generation</b>				
Total transmitter jitter (T_TJ)	1250	–	0.24	UI
<b>Gigabit Ethernet Receiver High Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	1250	0.749	–	UI

Table 61: XAUI Protocol Characteristics

Description	Line Rate (Mb/s)	Min	Max	Units
<b>XAUI Transmitter Jitter Generation</b>				
Total transmitter jitter (T_TJ)	3125	–	0.35	UI
<b>XAUI Receiver High Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	3125	0.65	–	UI

Table 62: PCI Express Protocol Characteristics<sup>(1)</sup>

Standard	Description	Line Rate (Mb/s)	Min	Max	Units	
<b>PCI Express Transmitter Jitter Generation</b>						
PCI Express Gen 1	Total transmitter jitter	2500	–	0.25	UI	
PCI Express Gen 2	Total transmitter jitter	5000	–	0.25	UI	
PCI Express Gen 3 <sup>(2)</sup>	Total transmitter jitter uncorrelated	8000	–	31.25	ps	
	Deterministic transmitter jitter uncorrelated		–	12	ps	
<b>PCI Express Receiver High Frequency Jitter Tolerance</b>						
PCI Express Gen 1	Total receiver jitter tolerance	2500	0.65	–	UI	
PCI Express Gen 2 <sup>(3)</sup>	Receiver inherent timing error	5000	0.40	–	UI	
	Receiver inherent deterministic timing error		0.30	–	UI	
PCI Express Gen 3 <sup>(2)</sup>	Receiver sinusoidal jitter tolerance	0.03 MHz–1.0 MHz	8000	1.00	–	UI
		1.0 MHz–10 MHz		Note 4	–	UI
		10 MHz–100 MHz		0.10	–	UI

**Notes:**

1. Tested per card electromechanical (CEM) methodology.
2. PCI-SIG 3.0 certification and compliance test boards are currently not available.
3. Using common REFCLK.
4. Between 1 MHz and 10 MHz the minimum sinusoidal jitter roll-off with a slope of 20dB/decade.

Table 63: CEI-6G and CEI-11G Protocol Characteristics

Description	Line Rate (Mb/s)	Interface	Min	Max	Units
<b>CEI-6G Transmitter Jitter Generation</b>					
Total transmitter jitter <sup>(1)</sup>	4976–6375	CEI-6G-SR	–	0.3	UI
		CEI-6G-LR	–	0.3	UI
<b>CEI-6G Receiver High Frequency Jitter Tolerance</b>					
Total receiver jitter tolerance <sup>(1)</sup>	4976–6375	CEI-6G-SR	0.6	–	UI
		CEI-6G-LR	0.95	–	UI
<b>CEI-11G Transmitter Jitter Generation</b>					
Total transmitter jitter <sup>(2)</sup>	9950–11100	CEI-11G-SR	–	0.3	UI
		CEI-11G-LR/MR	–	0.3	UI
<b>CEI-11G Receiver High Frequency Jitter Tolerance</b>					
Total receiver jitter tolerance <sup>(2)</sup>	9950–11100	CEI-11G-SR	0.65	–	UI
		CEI-11G-MR	0.65	–	UI
		CEI-11G-LR	0.825	–	UI

**Notes:**

1. Tested at most commonly used line rate of 6250 Mb/s using 390.625 MHz reference clock.
2. Tested at line rate of 9950 Mb/s using 155.46875 MHz reference clock and 11100 Mb/s using 173.4375 MHz reference clock.

Table 64: SFP+ Protocol Characteristics

Description	Line Rate (Mb/s)	Min	Max	Units
<b>SFP+ Transmitter Jitter Generation</b>				
Total transmitter jitter	9830.40 <sup>(1)</sup>	–	0.28	UI
	9953.00			
	10312.50			
	10518.75			
	11100.00			
<b>SFP+ Receiver Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	9830.40 <sup>(1)</sup>	0.7	–	UI
	9953.00			
	10312.50			
	10518.75			
	11100.00			

**Notes:**

1. Line rated used for CPRI over SFP+ applications.

Table 65: CPRI Protocol Characteristics

Description	Line Rate (Mb/s)	Min	Max	Units
<b>CPRI Transmitter Jitter Generation</b>				
Total transmitter jitter	614.4	–	0.35	UI
	1228.8	–	0.35	UI
	2457.6	–	0.35	UI
	3072.0	–	0.35	UI
	4915.2	–	0.3	UI
	6144.0	–	0.3	UI
	9830.4	–	Note 1	UI
<b>CPRI Receiver Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	614.4	0.65	–	UI
	1228.8	0.65	–	UI
	2457.6	0.65	–	UI
	3072.0	0.65	–	UI
	4915.2	0.95	–	UI
	6144.0	0.95	–	UI
	9830.4	Note 1	–	UI

**Notes:**

1. Tested per SFP+ specification, see Table 64.

## Integrated Interface Block for PCI Express Designs Switching Characteristics

More information and documentation on solutions for PCI Express designs can be found at:

<http://www.xilinx.com/technology/protocols/pciexpress.htm>

Table 66: Maximum Performance for PCI Express Designs

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
F <sub>PIPECLK</sub>	Pipe clock maximum frequency	250.00	250.00	250.00	250.00	MHz
F <sub>USERCLK</sub>	User clock maximum frequency	500.00	500.00	250.00	250.00	MHz
F <sub>USERCLK2</sub>	User clock 2 maximum frequency	250.00	250.00	250.00	250.00	MHz
F <sub>DRPCLK</sub>	DRP clock maximum frequency	250.00	250.00	250.00	250.00	MHz

## XADC Specifications

Table 67: XADC Specifications

Parameter	Symbol	Comments/Conditions	Min	Typ	Max	Units
$V_{CCADC} = 1.8V \pm 5\%$ , $V_{REFP} = 1.25V$ , $V_{REFN} = 0V$ , $ADCCLK = 26\text{ MHz}$ , $T_j = -40^\circ\text{C}$ to $100^\circ\text{C}$ , Typical values at $T_j = +40^\circ\text{C}$						
<b>ADC Accuracy<sup>(1)</sup></b>						
Resolution			12	–	–	Bits
Integral Nonlinearity <sup>(2)</sup>	INL		–	–	$\pm 3$	LSBs
Differential Nonlinearity	DNL	No missing codes, guaranteed monotonic	–	–	$\pm 1$	LSBs
Offset Error		Offset calibration enabled	–	–	$\pm 6$	LSBs
Gain Error		Gain calibration disabled	–	–	$\pm 0.5$	%
Offset Matching		Offset calibration enabled	–	–	4	LSBs
Gain Matching		Gain calibration disabled	–	–	0.3	%
Sample Rate			0.1	–	1	MS/s
Signal to Noise Ratio <sup>(2)</sup>	SNR	$F_{SAMPLE} = 500\text{KS/s}$ , $F_{IN} = 20\text{KHz}$	60	–	–	dB
RMS Code Noise		External 1.25V reference	–	–	2	LSBs
		On-chip reference	–	3	–	LSBs
Total Harmonic Distortion <sup>(2)</sup>	THD	$F_{SAMPLE} = 500\text{KS/s}$ , $F_{IN} = 20\text{KHz}$	–	70	–	dB
<b>ADC Accuracy at Extended Temperatures (-55°C to 125°C)</b>						
Resolution			10	–	–	Bits
Integral Nonlinearity <sup>(2)</sup>	INL		–	–	$\pm 1$	LSB (at 10 bits)
Differential Nonlinearity	DNL	No missing codes, guaranteed monotonic	–	–	$\pm 1$	
<b>Analog Inputs<sup>(3)</sup></b>						
ADC Input Ranges		Unipolar operation	0	–	1	V
		Bipolar operation	-0.5	–	+0.5	V
		Unipolar common mode range (FS input)	0	–	+0.5	V
		Bipolar common mode range (FS input)	+0.5	–	+0.6	V
Maximum External Channel Input Ranges		Adjacent channels set within these ranges should not corrupt measurements on adjacent channels	-0.1	–	$V_{CCADC}$	V
Auxiliary Channel Full Resolution Bandwidth	FRBW		250	–	–	KHz
<b>On-Chip Sensors</b>						
Temperature Sensor Error		$T_j = -40^\circ\text{C}$ to $100^\circ\text{C}$ .	–	–	$\pm 4$	$^\circ\text{C}$
		$T_j = -55^\circ\text{C}$ to $+125^\circ\text{C}$	–	–	$\pm 6$	$^\circ\text{C}$
Supply Sensor Error		Measurement range of $V_{CCAUX} 1.8V \pm 5\%$ $T_j = -40^\circ\text{C}$ to $+100^\circ\text{C}$	–	–	$\pm 1$	%
		Measurement range of $V_{CCAUX} 1.8V \pm 5\%$ $T_j = -55^\circ\text{C}$ to $+125^\circ\text{C}$	–	–	$\pm 2$	%
<b>Conversion Rate<sup>(4)</sup></b>						
Conversion Time - Continuous	$t_{CONV}$	Number of ADCCLK cycles	26	–	32	Cycles
Conversion Time - Event	$t_{CONV}$	Number of CLK cycles	–	–	21	Cycles
DRP Clock Frequency	DCLK	DRP clock frequency	8	–	250	MHz
ADC Clock Frequency	ADCCLK	Derived from DCLK	1	–	26	MHz
DCLK Duty Cycle			40	–	60	%

Table 67: XADC Specifications (Cont'd)

Parameter	Symbol	Comments/Conditions	Min	Typ	Max	Units
<b>XADC Reference<sup>(5)</sup></b>						
External Reference	V <sub>REFP</sub>	Externally supplied reference voltage	1.20	1.25	1.30	V
On-Chip Reference		Ground V <sub>REFP</sub> pin to AGND, T <sub>j</sub> = -40°C to 100°C	1.2375	1.25	1.2625	V

**Notes:**

- Offset and gain errors are removed by enabling the XADC automatic gain calibration feature. The values are specified for when this feature is enabled.
- Only specified for new BitGen option XADCEnhancedLinearity = ON.
- See the ADC chapter in [UG480: 7 Series FPGAs XADC User Guide](#) for a detailed description.
- See the Timing chapter in [UG480: 7 Series FPGAs XADC User Guide](#) for a detailed description.
- Any variation in the reference voltage from the nominal V<sub>REFP</sub> = 1.25V and V<sub>REFN</sub> = 0V will result in a deviation from the ideal transfer function. This also impacts the accuracy of the internal sensor measurements (i.e., temperature and power supply). However, for external ratiometric type applications allowing reference to vary by ±4% is permitted. On-chip reference variation is ±1%.

## Configuration Switching Characteristics

Table 68: Configuration Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Power-up Timing Characteristics</b>						
T <sub>PL</sub> <sup>(1)</sup>	Program latency	5	5	5	5	ms, Max
T <sub>POR</sub> <sup>(1)</sup>	Power-on reset (50 ms ramp rate time)	10/50	10/50	10/50	10/50	ms, Min/Max
	Power-on reset (1 ms ramp rate time)	10/35	10/35	10/35	10/35	ms, Min/Max
T <sub>PROGRAM</sub>	Program pulse width	250	250	250	250	ns, Min
<b>CCLK Output (Master Mode)</b>						
T <sub>ICCK</sub>	Master CCLK output delay	150	150	150	150	ns, Min
T <sub>MCCKL</sub>	Master CCLK clock Low time duty cycle	40/60	40/60	40/60	40/60	%, Min/Max
T <sub>MCCKH</sub>	Master CCLK clock High time duty cycle	40/60	40/60	40/60	40/60	%, Min/Max
F <sub>MCCK</sub>	Master CCLK frequency	100.00	100.00	100.00	70.00	MHz, Max
	Master CCLK frequency for AES encrypted x16	50.00	50.00	50.00	35.00	MHz, Max
F <sub>MCCK_START</sub>	Master CCLK frequency at start of configuration	3.00	3.00	3.00	3.00	MHz, Typ
F <sub>MCCKTOL</sub>	Frequency tolerance, master mode with respect to nominal CCLK	±50	±50	±50	±50	%, Max
<b>CCLK Input (Slave Modes)</b>						
T <sub>SCCKL</sub>	Slave CCLK clock minimum Low time	2.50	2.50	2.50	2.50	ns, Min
T <sub>SCCKH</sub>	Slave CCLK clock minimum High time	2.50	2.50	2.50	2.50	ns, Min
F <sub>SCCK</sub>	Slave CCLK frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>EMCCLK Input (Master Mode)</b>						
T <sub>EMCCKL</sub>	External master CCLK Low time	2.50	2.50	2.50	2.50	ns, Min
T <sub>EMCCKH</sub>	External master CCLK High time	2.50	2.50	2.50	2.50	ns, Min
F <sub>EMCCK</sub>	External master CCLK frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>Master/Slave Serial Mode Programming Switching</b>						
T <sub>DCCK</sub> /T <sub>CCKD</sub>	DIN Setup/Hold	4.00/0.00	4.00/0.00	4.00/0.00	5.00/0.00	ns, Min
T <sub>CCO</sub>	DOUT clock to out	8.00	8.00	8.00	9.00	ns, Max



Table 68: Configuration Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V			0.9V	
		-3	-2/-2L	-1	-2L	
<b>SelectMAP Mode Programming Switching</b>						
T <sub>SMDCCK</sub> /T <sub>SMCCKD</sub>	D[31:00] Setup/Hold	4.00/0.00	4.00/0.00	4.00/0.00	4.50/0.00	ns, Min
T <sub>SMCSCCK</sub> /T <sub>SMCCKCS</sub>	CSI_B Setup/Hold	4.00/0.00	4.00/0.00	4.00/0.00	5.00/0.00	ns, Min
T <sub>SMWCCCK</sub> /T <sub>SMCCKW</sub>	RDWR_B Setup/Hold	10.00/0.00	10.00/0.00	10.00/0.00	12.00/0.00	ns, Min
T <sub>SMCKCSO</sub>	CSO_B clock to out (330 Ω pull-up resistor required)	7.00	7.00	7.00	8.00	ns, Max
T <sub>SMCO</sub>	D[31:00] clock to out in readback	8.00	8.00	8.00	10.00	ns, Max
F <sub>RBCK</sub>	Readback frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>Boundary-Scan Port Timing Specifications</b>						
T <sub>TAPTCK</sub> /T <sub>TCKTAP</sub>	TMS and TDI Setup/Hold	3.00/2.00	3.00/2.00	3.00/2.00	3.00/2.00	ns, Min
T <sub>TCKTDO</sub>	TCK falling edge to TDO output	7.00	7.00	7.00	8.50	ns, Max
F <sub>TCK</sub>	TCK frequency	66.00	66.00	66.00	50.00	MHz, Max
<b>BPI Master Flash Mode Programming Switching</b>						
T <sub>BPICCO</sub> <sup>(2)</sup>	A[28:00], RS[1:0], FCS_B, FOE_B, FWE_B, ADV_B clock to out	8.50	8.50	8.50	10.00	ns, Max
T <sub>BPIDCC</sub> /T <sub>BPICCD</sub>	D[15:00] Setup/Hold	4.00/0.00	4.00/0.00	4.00/0.00	4.50/0.00	ns, Min
<b>SPI Master Flash Mode Programming Switching</b>						
T <sub>SPIDCC</sub> /T <sub>SPICCD</sub>	D[03:00] Setup/Hold	3.00/0.00	3.00/0.00	3.00/0.00	3.00/0.00	ns, Min
T <sub>SPICCM</sub>	MOSI clock to out	8.00	8.00	8.00	9.00	ns, Max
T <sub>SPICFC</sub>	FCS_B clock to out	8.00	8.00	8.00	9.00	ns, Max

**Notes:**

1. To support longer delays in configuration, use the design solutions described in [UG470: 7 Series FPGA Configuration User Guide](#).
2. Only during configuration, the last edge is determined by a weak pull-up/pull-down resistor in the I/O.

## eFUSE Programming Conditions

Table 69 lists the programming conditions specifically for eFUSE. For more information, see [UG470: 7 Series FPGA Configuration User Guide](#).

Table 69: eFUSE Programming Conditions<sup>(1)</sup>

Symbol	Description	Min	Typ	Max	Units
I <sub>FS</sub>	V <sub>CCAUX</sub> supply current	–	–	115	mA
t <sub>j</sub>	Temperature range	15	–	125	°C

**Notes:**

1. The FPGA must not be configured during eFUSE programming.

## Revision History

The following table shows the revision history for this document:

Date	Version	Description
03/01/11	1.0	Initial Xilinx release.
04/01/11	1.1	Added the XC7K355T, XC7K420T, and XC7K480T devices throughout data sheet. Added the extended temperature range discussion to <a href="#">page 1</a> . Updated $V_{CCAUX\_IO}$ in <a href="#">Table 2</a> . Edits to clarify <a href="#">Power-On/Off Power Supply Sequencing</a> power sequencing discussion. Added $I_{CCAUX\_IO}$ and $I_{CCBRAM}$ to <a href="#">Table 6</a> and <a href="#">Table 7</a> . Updated $MMCM\_FINDUTY$ and added $F_{INJITTER}$ , $T_{OUTJITTER}$ , $T_{EXTFVAR}$ , and <a href="#">Note 3</a> to <a href="#">Table 38</a> . Removed the SBG324 package from <a href="#">Table 50</a> . Updated the <a href="#">Notice of Disclaimer</a> .
10/04/11	1.2	Replaced -1L with -2L throughout this data sheet. Updated Min/Max values and removed <a href="#">Note 5</a> from <a href="#">Table 2</a> . Clarified <a href="#">Power-On/Off Power Supply Sequencing</a> power sequencing discussion including adding $T_{VCCO2VCCAUX}$ to <a href="#">Table 8</a> . Updated $V_{ICM}$ in <a href="#">Table 12</a> and <a href="#">Table 13</a> . Added <a href="#">Note 1</a> to <a href="#">table 12</a> . Updated <a href="#">Table 69</a> including adding <a href="#">Note 1</a> . Added <i>Absolute Maximum Ratings for GTX Transceivers</i> . Revised the reference clock maximum frequency ( $F_{GCLK}$ ) in <a href="#">Table 55</a> . Added <a href="#">Table 57</a> . Added LVTTTL and removed SSTL135_II and SSTL15_II specifications from <a href="#">Table 19</a> . Removed HSTL_III from <a href="#">Table 20</a> . Removed the <i>I/O Standard Adjustment Measurement Methodology</i> section. Use IBIS for more accurate information and measurements. Updated $T_{DELAYPAT\_JIT}$ in <a href="#">Table 26</a> . Added $T_{AS}/T_{AH}$ to <a href="#">Table 28</a> . Added $T_{RDCK\_DI\_WF\_NC}/T_{RCKD\_DI\_WF\_NC}$ and $T_{RDCK\_DI\_RF}/T_{RCKD\_DI\_RF}$ to <a href="#">Table 31</a> . Completely updated <a href="#">Table 68</a> . Updated the <a href="#">AC Switching Characteristics</a> in <a href="#">Table 19</a> , <a href="#">Table 20</a> , <a href="#">Table 21</a> , <a href="#">Table 22</a> , <a href="#">Table 23</a> , <a href="#">Table 24</a> , <a href="#">Table 26</a> through <a href="#">Table 38</a> , <a href="#">Table 40</a> though <a href="#">Table 37</a> , and <a href="#">Table 67</a> .
11/03/11	1.3	Revised the $V_{OCM}$ specification in <a href="#">Table 12</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.3 v1.02 speed specification throughout document including <a href="#">Table 19</a> and <a href="#">Table 20</a> . Added $MMCM\_T_{FBDELAY}$ while adding $MMCM\_$ to the symbol names of a few specifications in <a href="#">Table 38</a> and PLL to the symbol names in <a href="#">Table 39</a> . In <a href="#">Table 40</a> through <a href="#">Table 47</a> , updated the pin-to-pin descriptions with the SSTL15 standard. Updated units in <a href="#">Table 49</a> .
02/13/12	1.4	Updated summary description on <a href="#">page 1</a> . In <a href="#">Table 2</a> , revised $V_{CCO}$ for the 3.3V HR I/O banks and updated $T_j$ . Added typical values to <a href="#">Table 3</a> . Updated the notes in <a href="#">Table 6</a> . Added MGTAVCC, MGTAVTT, and MGTVCCAUX power supply ramp times to <a href="#">Table 8</a> . Rearranged <a href="#">Table 9</a> , added Mobile_DDR, HSTL_I_18, HSTL_II_18, HSUL_12, SSTL135_R, SSTL15_R, and SSTL12 and removed DIFF_SSTL135, DIFF_SSTL18_I, DIFF_SSTL18_II, DIFF_HSTL_I, and DIFF_HSTL_II. Added <a href="#">Table 10</a> and <a href="#">Table 11</a> . Revised the specifications in <a href="#">Table 12</a> and <a href="#">Table 13</a> . Updated the <a href="#">eFUSE Programming Conditions</a> section and removed the endurance table. Added the <a href="#">IO_FIFO Switching Characteristics</a> table. Revised $I_{CCADC}$ and updated <a href="#">Note 1</a> in <a href="#">Table 67</a> . Revised DDR LVDS transmitter data width in <a href="#">Table 16</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 13.4 v1.03 speed specification throughout document. Removed notes from <a href="#">Table 28</a> as they are no longer applicable. Updated specifications in <a href="#">Table 68</a> . Updated <a href="#">Note 1</a> in <a href="#">Table 37</a> . In the <a href="#">GTX Transceiver DC Input and Output Levels</a> section: Revised $V_{IN}$ , and added $I_{DCIN}$ and $I_{DCOUT}$ to <a href="#">Table 51</a> . Added <a href="#">Note 4</a> to <a href="#">Table 53</a> . In <a href="#">Table 55</a> , revised $F_{GCLK}$ , removed $T_{PHASE}$ , and added $T_{DLOCK}$ . Revised specifications and added <a href="#">Note 2</a> to <a href="#">Table 57</a> . Added <a href="#">Table 58</a> and <a href="#">Table 59</a> along with <a href="#">GTX Transceiver Protocol Jitter Characteristics</a> in <a href="#">Table 60</a> through <a href="#">Table 65</a> .
05/23/12	1.5	Reorganized entire data sheet including adding <a href="#">Table 44</a> and <a href="#">Table 48</a> . Updated $T_{SOL}$ in <a href="#">Table 1</a> . Updated $I_{BATT}$ and added $R_{IN\_TERM}$ to <a href="#">Table 3</a> . Added values to <a href="#">Table 6</a> and <a href="#">Table 7</a> . Updated <a href="#">Power-On/Off Power Supply Sequencing</a> , <a href="#">page 6</a> with regards to GTX transceivers. Updated many parameters in <a href="#">Table 9</a> including SSTL135 and SSTL135_R. Removed $V_{OX}$ column and added DIFF_HSUL_12 to <a href="#">Table 11</a> . Updated $V_{OL}$ in <a href="#">Table 12</a> . Updated <a href="#">Table 16</a> and removed notes 2 and 3. Updated <a href="#">Table 17</a> . Updated the <a href="#">AC Switching Characteristics</a> based upon the ISE 14.1 v1.04 for the -3, -2, -2L (1.0V), -1, and -2L (0.9V) speed specifications throughout the document. In <a href="#">Table 31</a> , updated <a href="#">Reset Delays</a> section including <a href="#">Note 10</a> and <a href="#">Note 11</a> . Added data for $T_{LOCK}$ and $T_{DLOCK}$ in <a href="#">Table 55</a> . Updated many of the XADC specifications in <a href="#">Table 67</a> and added <a href="#">Note 2</a> . Updated and moved <i>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</i> section from <a href="#">Table 68</a> to <a href="#">Table 38</a> and <a href="#">Table 39</a> .

Date	Version	Description
07/25/12	1.6	<p>Updated the descriptions, changed <math>V_{IN}</math> and <a href="#">Note 2</a> and added <a href="#">Note 4</a> in <a href="#">Table 1</a>. In <a href="#">Table 2</a>, changed descriptions and notes, removed <a href="#">Note 7</a>, changed GTX transceiver parameters and values and added <a href="#">Note 9</a>. Updated parameters in <a href="#">Table 3</a>. Added <a href="#">Table 4</a> and <a href="#">Table 5</a>.</p> <p>Changed the typical values for many of the devices in <a href="#">Table 7</a>. Updated LVCMOS12 and the SSTLs in <a href="#">Table 9</a>. Updated many of the specifications in <a href="#">Table 10</a> and <a href="#">Table 11</a>.</p> <p>Updated speed specification to v1.06 (-3, -2, -2L(1.0V), -1) and v1.05 (-2L(0.9V)) with appropriate changes to <a href="#">Table 14</a> and <a href="#">Table 15</a> including production release of the XC7K325T and the XC7K410T in the -2, -2L(1.0V), and -1 speed designations.</p> <p>Added notes and specifications to <a href="#">Table 17</a> and <a href="#">Table 18</a>.</p> <p>Updated the <a href="#">IOB Pad Input/Output/3-State</a> discussion and changed <a href="#">Table 21</a> by adding <math>T_{IOIBUFDISABLE}</math>.</p> <p>Removed many of the combinatorial delay specifications and <math>T_{CINCK}/T_{CKCIN}</math> from <a href="#">Table 28</a>.</p> <p>Rearranged <a href="#">Table 51</a> including moving some parameters to <a href="#">Table 1</a>. Added <a href="#">Table 56</a>. Updated <a href="#">Table 57</a>. In <a href="#">Table 59</a>, updated SJ Jitter Tolerance with Stressed Eye section, <a href="#">page 51</a> and <a href="#">Note 8</a>. Added <a href="#">Note 1</a>, <a href="#">Note 2</a>, and <a href="#">Note 3</a> to <a href="#">Table 62</a>. Added <a href="#">Note 1</a> and <a href="#">Note 2</a> to <a href="#">Table 63</a>, and line rate ranges. Updated <a href="#">Table 64</a> including adding <a href="#">Note 1</a>. Updated <a href="#">Table 65</a> including adding <a href="#">Note 1</a>. In <a href="#">Table 67</a> updated <a href="#">Note 1</a> and added <a href="#">Note 4</a>. In <a href="#">Table 68</a>, updated <math>T_{POR}</math> and <math>F_{EMCCK}</math>.</p>
09/04/12	1.7	<p>Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K160T in the -2, -2L(1.0V), and -1 speed designations.</p>
09/26/12	1.8	<p>In <a href="#">Table 2</a>, revised <math>V_{CCINT}</math> and <math>V_{CCBRAM}</math> and added <a href="#">Note 2</a>. Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K480T in the -2, -2L(1.0V), and -1 speed designations and the XC7K325T and XC7K410T in the -3 speed designation.</p>
10/10/12	1.9	<p>Updated the <math>I_{CCINTMIN}</math> value for the XC7K355T in <a href="#">Table 7</a>. Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K420T in the -2, -2L(1.0V), and -1 speed designations.</p>
10/25/12	2.0	<p>Updated the <a href="#">AC Switching Characteristics</a> based upon ISE 14.3 v1.07 for the -3, -2, -2L (1.0V), -1 speed specifications, and ISE 14.3 v1.06 for the -2L (0.9V) speed specifications throughout the document.</p> <p>Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K355T in the -2, -2L(1.0V), and -1 speed designations. Also updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K325T and XC7K410T in the -2L (0.9V).</p> <p>Added values for <a href="#">Table 16</a> -2L (0.9V). Added package skew values to <a href="#">Table 50</a>. In <a href="#">Table 53</a>, increased -1 speed grade (FF package) <math>F_{GTXMAX}</math> value from 6.6 Gb/s to 8.0 Gb/s.</p>
10/31/12	2.1	<p>Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K70T in the -2, -2L(1.0V), and -1 speed designations.</p>
11/26/12	2.2	<p>Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of -3 speed designation for XC7K70T, XC7K160T, XC7K355T, XC7K420T, and XC7K480T. Removed <a href="#">Note 4</a> from <a href="#">Table 67</a>.</p>
12/05/12	2.3	<p>Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of -2L (0.9V) speed designation for XC7K160T, XC7K420T, and XC7K480T. Updated <a href="#">Note 1</a> in <a href="#">Table 50</a>.</p>

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